A MINI-COURSE ON THE

PRINCIPLES OF PLASMA DISCHARGES

Michael A. Lieberman

Rf or microwave
power

e, CF_3, CF_3^+, F, O^-, O_2, CO, SiF_4, etc.

Plasma

CF_4/O_2 →

SiO_2

Si

→ Pump
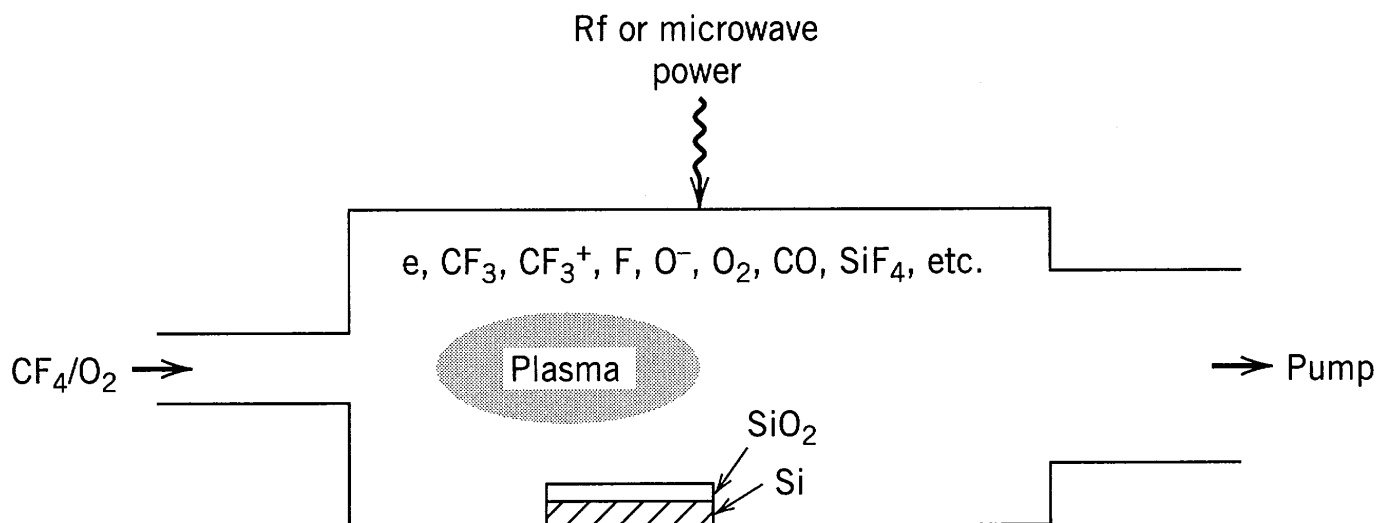
OUTLINE

- Introduction to Plasma Discharges and Processing

- Summary of Plasma Fundamentals

    — Break —

- Summary of Discharge Fundamentals

- Analysis of Discharge Equilibrium

- Inductive RF Discharges

ORIGIN OF MINI-COURSE

45 hr graduate course at Berkeley $\Longrightarrow$

12 hr short course in industry $\Longrightarrow$

4 hr mini-course

INTRODUCTION TO PLASMA DISCHARGES

AND PROCESSING

PLASMAS AND DISCHARGES

- Plasmas:

  A collection of freely moving charged particles which is, on the average, electrically neutral
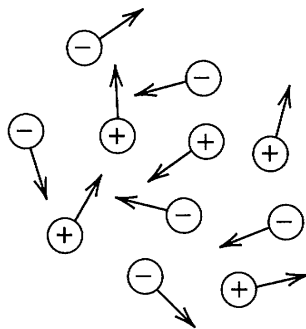
- Discharges:

  Are driven by voltage or current sources

  Charged particle collisions with neutral particles are important
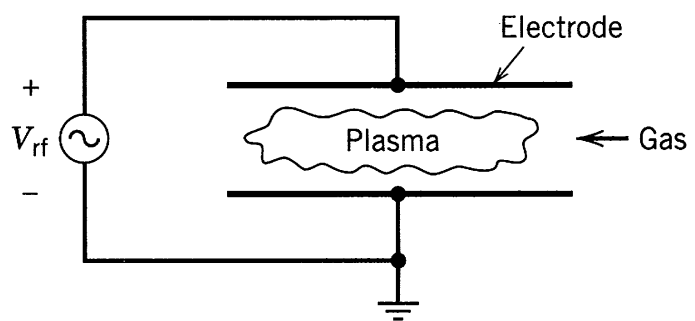
  There are boundaries at which surface losses are important

  Ionization of neutrals sustains the plasma in the steady state

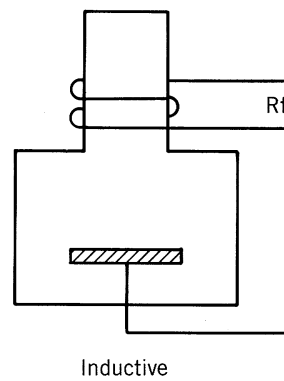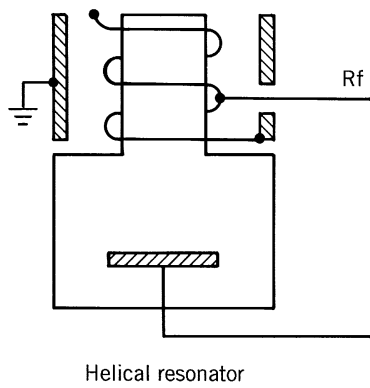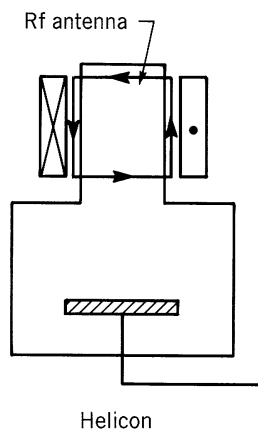 The electrons are not in thermal equilibrium with the ions
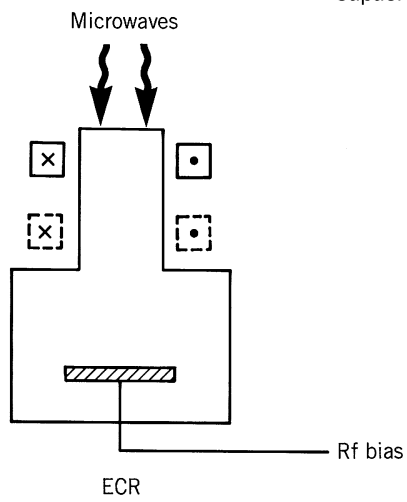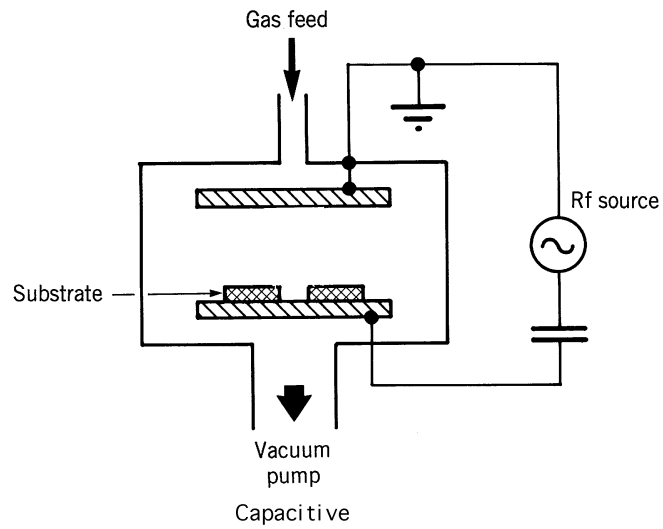

(a)   (b)

- Device sizes $\sim$ 30 cm – 1 m
- Driving frequencies from DC to rf (13.56 MHz) to microwaves (2.45 GHz)

TYPICAL PROCESSING DISCHARGES

Gas feed

Rf source

Substrate

Vacuum
pump

Capacitive

Microwaves

ECR

Rf bias

Rf antenna

Helicon

Helical resonator

Rf

Inductive

Rf

RANGE OF MICROELECTRONICS APPLICATIONS

- Etching

  Si, a-Si, oxide, nitride, III-V's

- Ashing

  Photoresist removal

- Deposition (PECVD)

  Oxide, nitride, a-Si

- Oxidation

  Si

- Sputtering
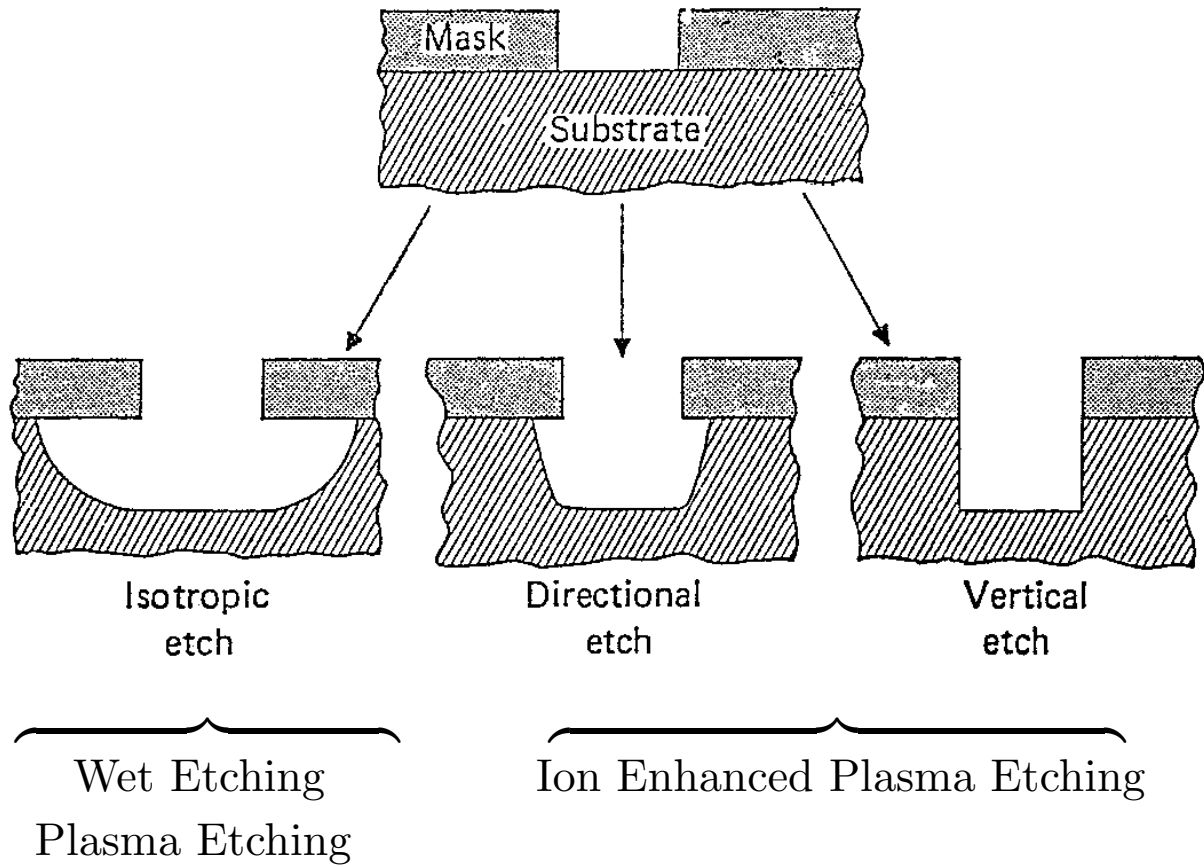
  Al, W, Au, Cu, YBaCuO

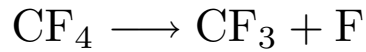
- Polymerization

  Various plastics

- Implantation

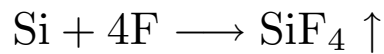 H, He, B, P, O, As, Pd

ANISOTROPIC ETCHING

Isotropic etch   Directional etch   Vertical etch

Wet Etching
Plasma Etching

Ion Enhanced Plasma Etching

ISOTROPIC PLASMA ETCHING

1. Start with inert molecular gas CF_4

2. Make discharge to create reactive species:
$$CF_4 \longrightarrow CF_3 + F$$

3. Species reacts with material, yielding volatile product:
$$Si + 4F \longrightarrow SiF_4 \uparrow$$

4. Pump away product

5. CF_4 does not react with Si; SiF_4 is volatile

ANISOTROPIC PLASMA ETCHING

6. Energetic ions bombard trench bottom, but not sidewalls:

   (a) Increase etching reaction rate at trench bottom

   (b) Clear passivating films from trench bottom
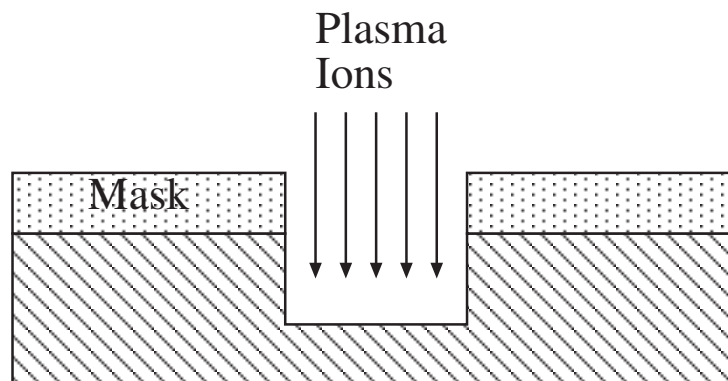
UNITS AND CONSTANTS

- SI units: meters (m), kilograms (kg), seconds (s), coulombs (C)

  $e = 1.6 \times 10^{-19}$ C, electron charge $= -e$

- Energy unit is joule (J)

  Often use electron-volt

  $$1 \text{ eV} = 1.6 \times 10^{-19} \text{ J}$$

- Temperature unit is kelvin (K)

  Often use equivalent voltage of the temperature:

  $$\boxed{\text{T}_e(\text{volts}) = \frac{kT_e(\text{kelvins})}{e}}$$

  where k = Boltzmann's constant $= 1.38 \times 10^{-23}$ J/K

  $$\boxed{1 \text{ V} \Longleftrightarrow 11,600 \text{ K}}$$

- Pressure unit is pascals (Pa); 1 Pa $= 1$ N/m^2

  Atmospheric pressure $\approx 10^5$ Pa $\equiv 1$ bar

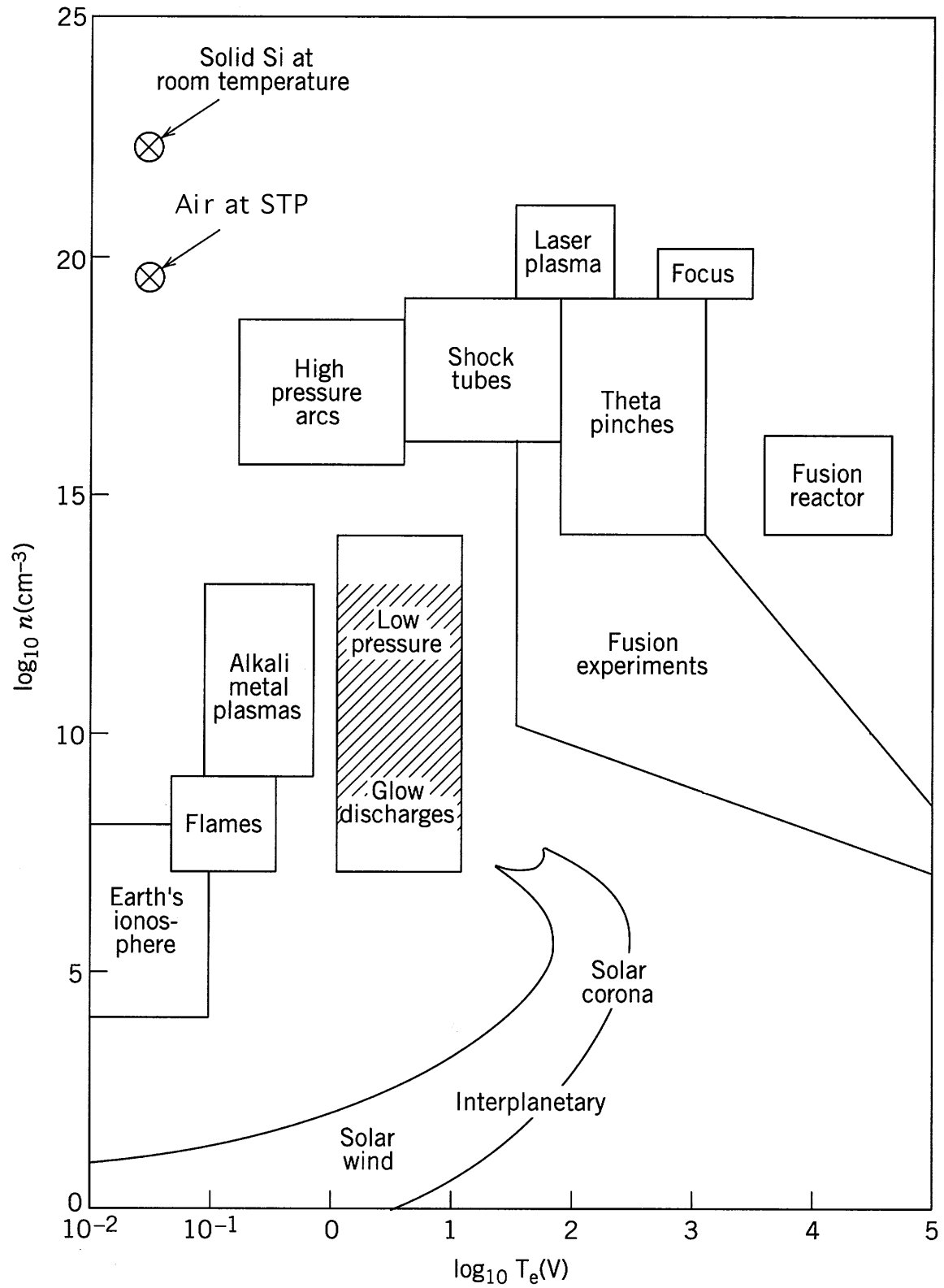 Often use English units for gas pressures

  Atmospheric pressure $= 760$ Torr

  $$1 \text{ Pa} \Longleftrightarrow 7.5 \text{ mTorr}$$
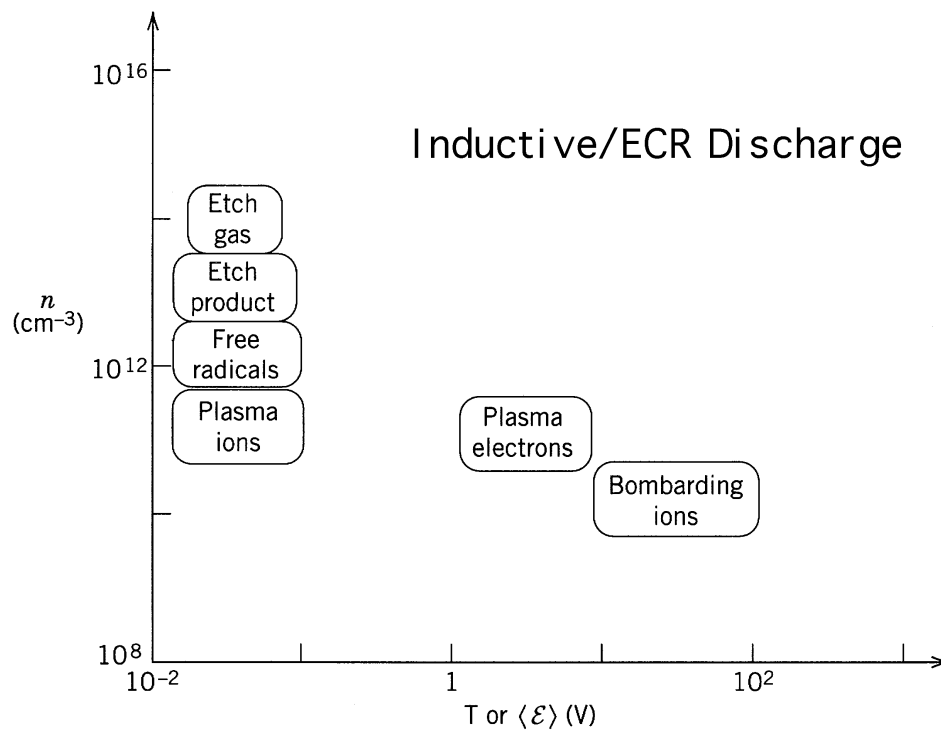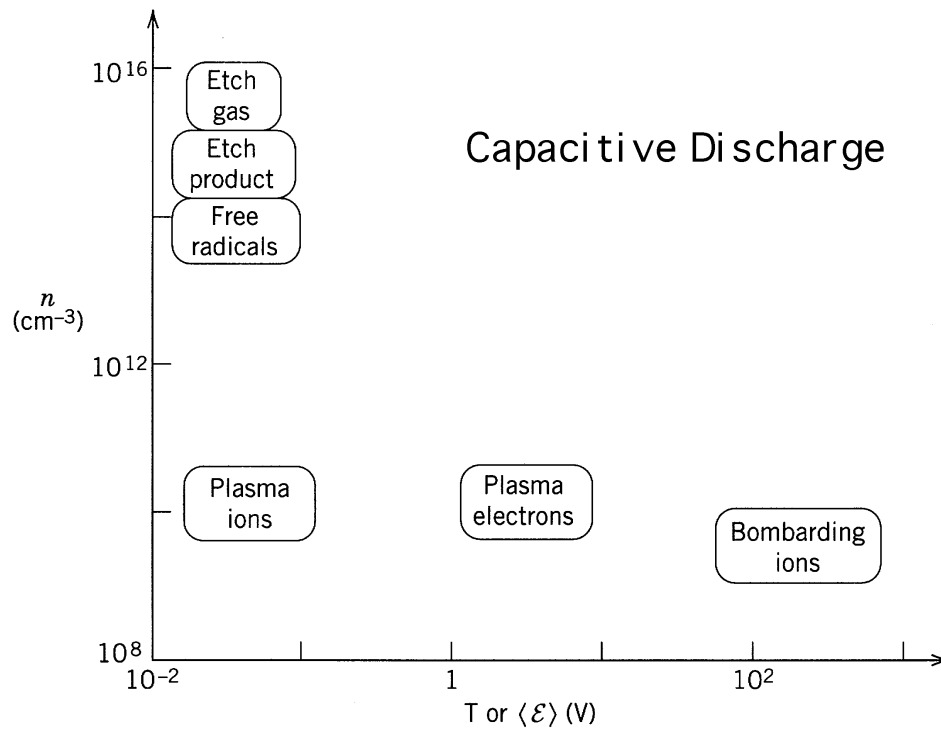
PHYSICAL CONSTANTS AND CONVERSION FACTORS

Quantity	Symbol	Value
Boltzmann constant	k	1.3807×10^{-23} J/K
Elementary charge	e	1.6022×10^{-19} C
Electron mass	m	9.1095×10^{-31} kg
Proton mass	M	1.6726×10^{-27} kg
Proton/electron mass ratio	M/m	1836.2
Planck constant	h	6.6262×10^{-34} J-s
	$\hbar = h/2\pi$	1.0546×10^{-34} J-s
Speed of light in vacuum	c_0	2.9979×10^{8} m/s
Permittivity of free space	ϵ_0	8.8542×10^{-12} F/m
Permeability of free space	μ_0	$4\pi \times 10^{-7}$ H/m
Bohr radius	$a_0 = 4\pi\epsilon_0\hbar^2/e^2 m$	5.2918×10^{-11} m
Atomic cross section	πa_0^2	8.7974×10^{-21} m^2
Temperature T associated with T = 1 V		11605 K
Energy associated with $\mathcal{E} = 1$ V		1.6022×10^{-19} J
Avogadro number (molecules/mol)	N_A	6.0220×10^{23}
Gas constant	$R = kN_A$	8.3144 J/K-mol
Atomic mass unit		1.6606×10^{-27} kg
Standard temperature (25 °C)	T_0	298.15 K
Standard pressure (760 Torr = 1 atm)	$p^{\ominus}$	1.0133×10^{5} Pa
Loschmidt's number (density at STP)	$n^{\ominus}$	2.6868×10^{25} m^{-3}
Pressure of 1 Torr		133.32 Pa
Energy per mole at T_0	RT_0	2.4789 kJ/mol
calorie (cal)		4.1868 J

PLASMA DENSITY VERSUS TEMPERATURE

RELATIVE DENSITIES AND ENERGIES

Capacitive Discharge

10^{16}

Etch gas

Etch product

Free radicals

n
(cm^{-3})

10^{12}

Plasma ions

Plasma electrons

Bombarding ions

10^8

10^{-2} 1 10^2

T or $\langle \mathcal{E} \rangle$ (V)

Inductive/ECR Discharge

10^{16}

n
(cm^{-3})

Etch gas

Etch product

Free radicals

10^{12}

Plasma ions

Plasma electrons

Bombarding ions

10^8

10^{-2} 1 10^2

T or $\langle \mathcal{E} \rangle$ (V)
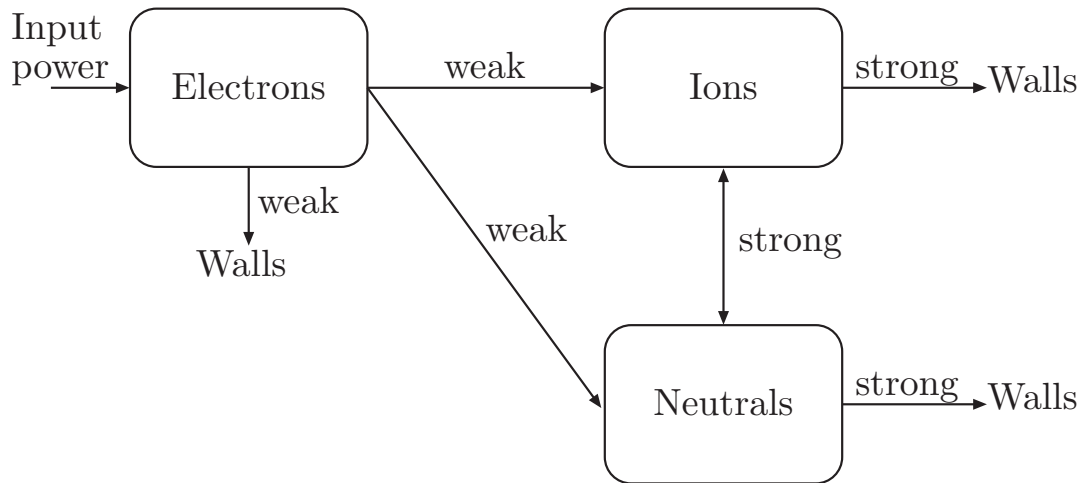
NON-EQUILIBRIUM

- Energy coupling between electrons and heavy particles is weak

- Electrons are *not* in thermal equilibrium with ions or neutrals

$$T_e \gg T_i \quad \text{in plasma bulk}$$

$$\text{Bombarding } \mathcal{E}_i \gg \mathcal{E}_e \quad \text{at wafer surface}$$

- "High temperature processing at low temperatures"

  1. Wafer can be near room temperature

  2. Electrons produce free radicals $\Longrightarrow$ chemistry

  3. Electrons produce electron-ion pairs $\Longrightarrow$ ion bombardment

ELEMENTARY DISCHARGE BEHAVIOR

- Consider uniform density of electrons and ions n_e and n_i at time $t = 0$
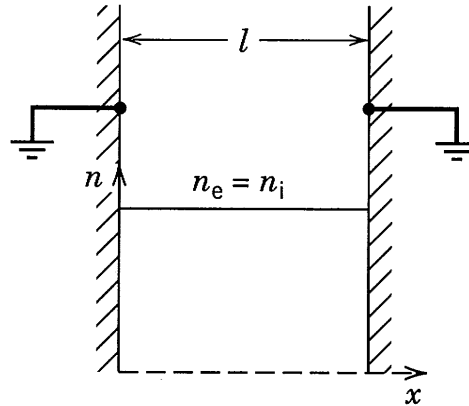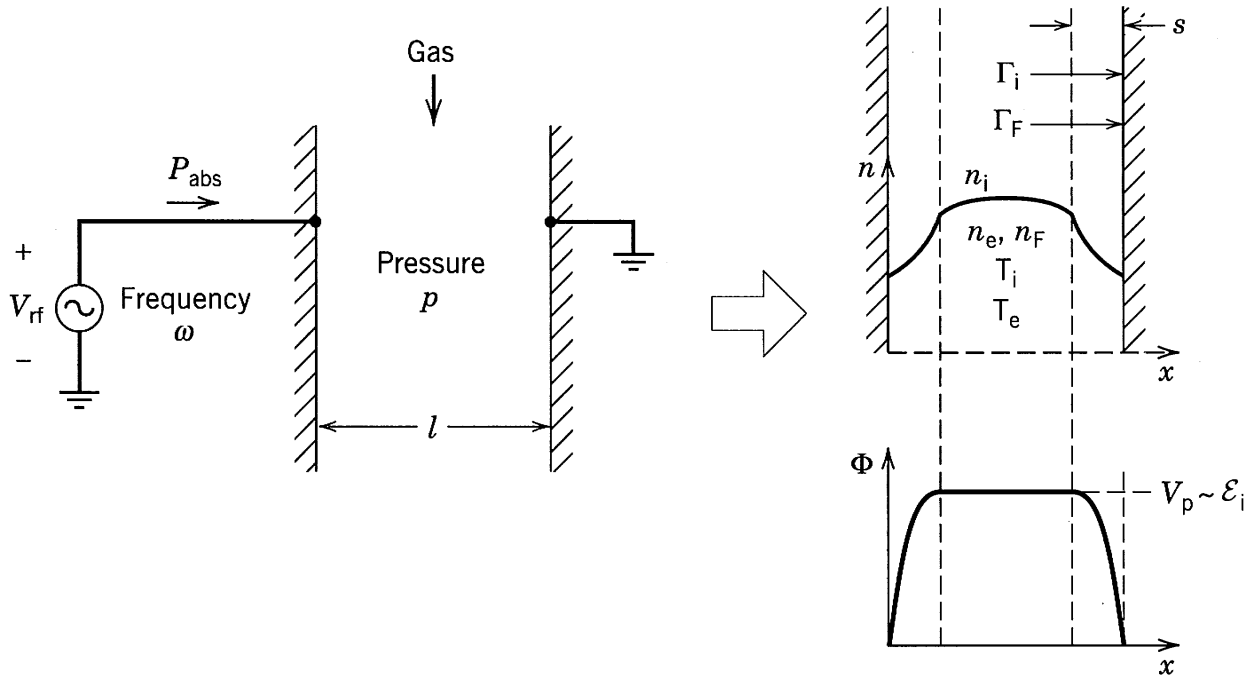
- Warm electrons having low mass quickly drain to the wall, setting up sheaths
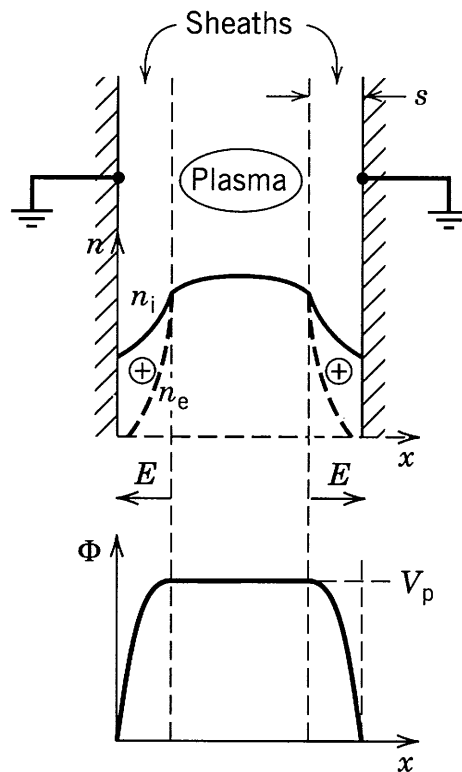
- Ions accelerated to walls; ion bombarding energy $\mathcal{E}_i$ = plasma-wall potential V_p

CENTRAL PROBLEM IN DISCHARGE MODELING

- Given $V_{\rm rf}$ (or $I_{\rm rf}$ or $P_{\rm rf}$), ω, gases, pressure, flow rates, discharge geometry (R, l, etc), then

- Find plasma densities n_e, n_i, temperatures T_e, T_i, ion bombarding energies $\mathcal{E}_i$, sheath thicknesses, neutral radical densities, potentials, currents, fluxes, etc

- Learn how to design and optimize plasma reactors for various purposes (etching, deposition, etc)

CHOOSING PLASMA PROCESSING EQUIPMENT

DECR

MERIE

Planar Magnetron

Triode

ECR

MCR

Helical Resonator
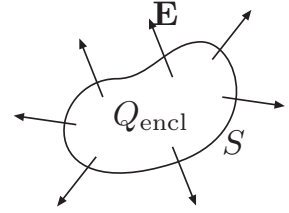
Helicon
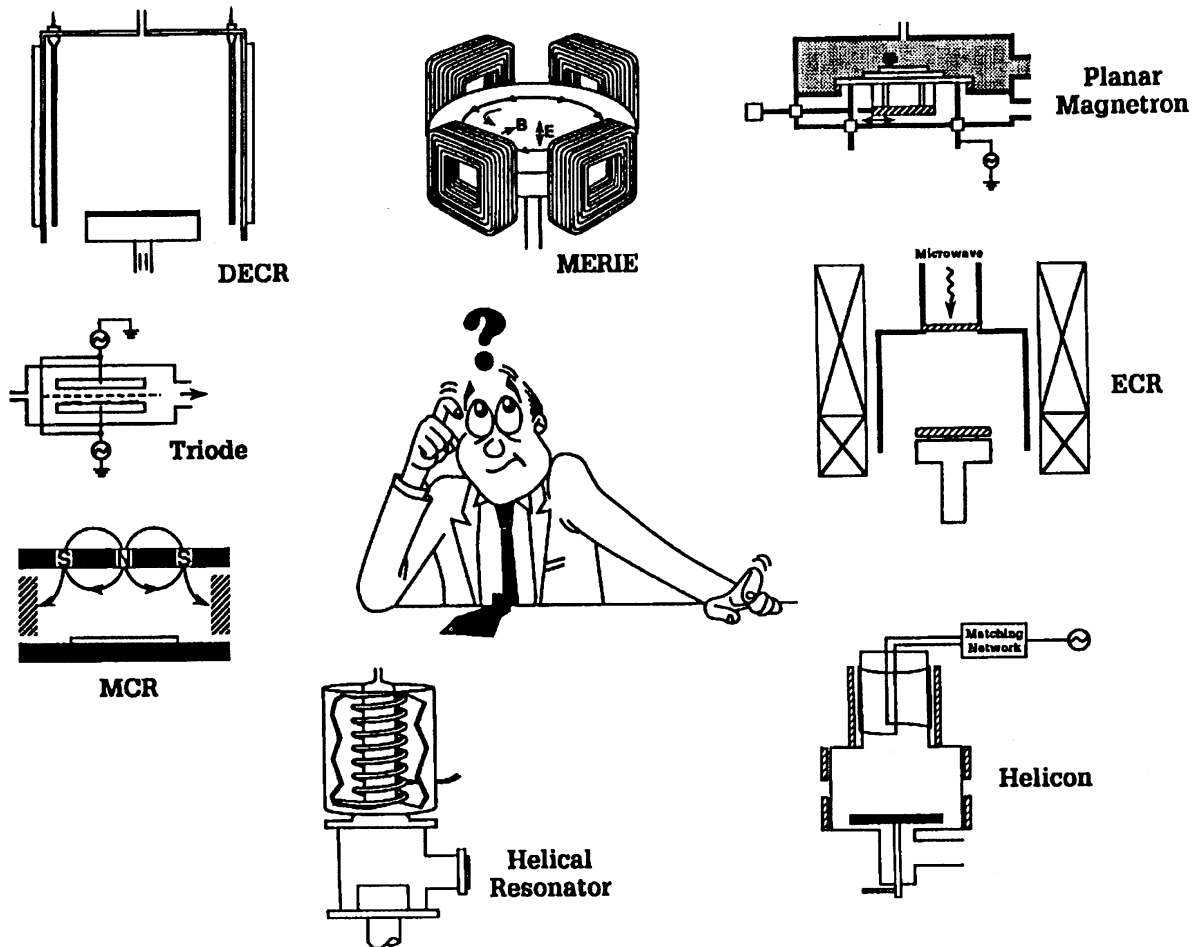
- How about inductive? (figure published in 1991)

SUMMARY OF PLASMA FUNDAMENTALS

POISSON'S EQUATION

- An electric field can be generated by charges:

$$\nabla \cdot \mathbf{E} = \frac{\rho}{\epsilon_0} \qquad \text{or} \qquad \oiint_S \bar{\mathbf{E}} \cdot d\mathbf{A} = \frac{Q_{\text{encl}}}{\epsilon_0}$$

- For slow time variations (dc, rf, but not microwaves):

$$\mathbf{E} = -\nabla \Phi$$

Combining these yields Poisson's equation:

$$\nabla^2 \Phi = -\frac{\rho}{\epsilon_0}$$

- Here $\mathbf{E}$ = electric field (V/m), ρ = charge density (C/m^3), Φ = potential (V)
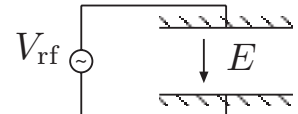
- In 1D:

$$\frac{dE_x}{dx} = \frac{\rho}{\epsilon_0}, \qquad E_x = -\frac{d\Phi}{dx}$$

yields

$$\boxed{\frac{d^2\Phi}{dx^2} = -\frac{\rho}{\epsilon_0}}$$

- This field powers a capacitive discharge or the wafer bias power of an inductive or ECR discharge
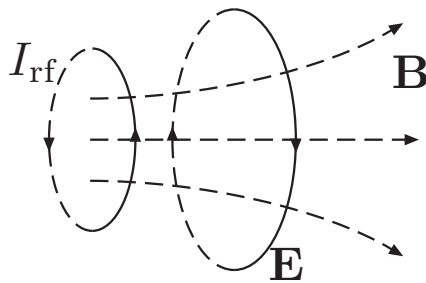
V_{rf} E

FARADAY'S LAW

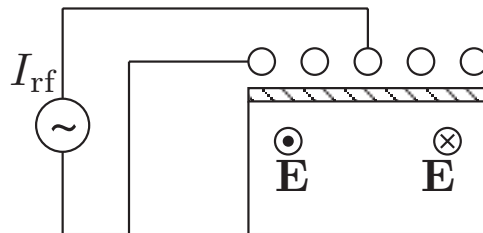- An electric field can be generated by a time-varying magnetic field:

$$\nabla \times \mathbf{E} = -\frac{\partial \mathbf{B}}{\partial t}$$

or

$$\oint_{\mathcal{C}} \mathbf{E} \cdot d\mathbf{l} = -\frac{\partial}{\partial t} \iint_{\mathcal{A}} \mathbf{B} \cdot d\mathbf{A}$$

- Here $\mathbf{B}$ = magnetic induction vector

- This field powers the coil of an inductive discharge (top power)

AMPERE'S LAW

- Both conduction currents and displacement currents generate magnetic fields:

$$\nabla \times \mathbf{H} = \mathbf{J}_c + \epsilon_0 \frac{\partial \mathbf{E}}{\partial t} = \mathbf{J}_T$$

- $\mathbf{J}_c$ = conduction current, $\epsilon_0 \partial \mathbf{E}/\partial t$ = displacement current, $\mathbf{J}_T$ = total current, $\mathbf{H}$ = magnetic field vector, $\mathbf{B} = \mu_0 \mathbf{H}$ with $\mu_0 = 4\pi \times 10^{-6}$ H/m
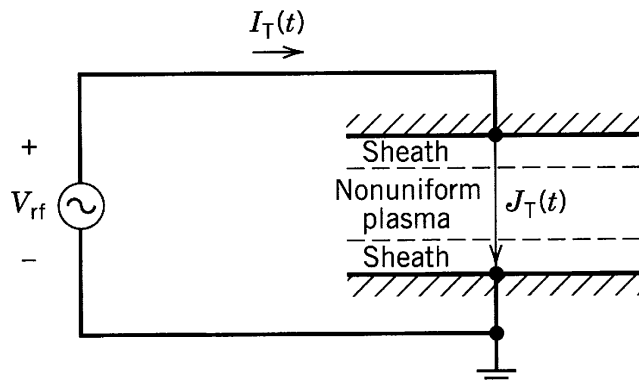
- Note the vector identity:

$$\nabla \cdot (\nabla \times \mathbf{H}) = 0 \qquad \Rightarrow \qquad \nabla \cdot \mathbf{J}_T = 0$$

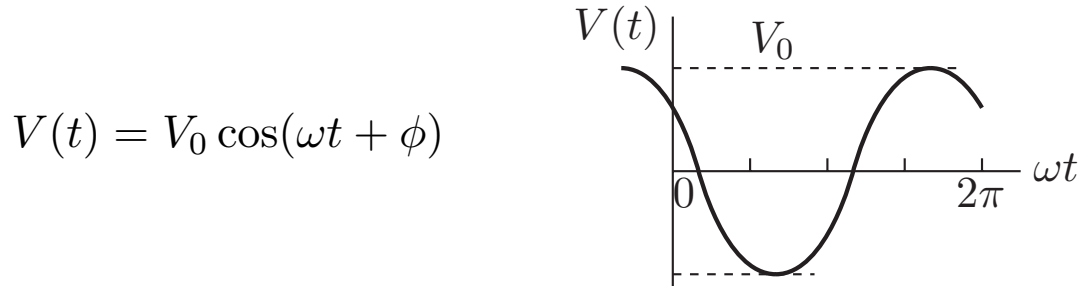- In 1D:

$$\frac{\partial J_{Tx}(x,\,t)}{\partial x} = 0$$

so
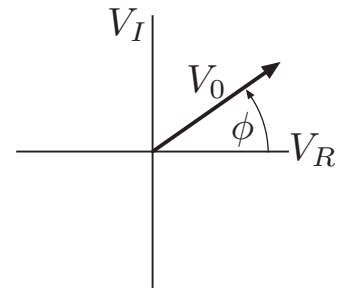
$$\boxed{J_{Tx} = J_{Tx}(t), \ \text{independent of } x}$$

-16-

REVIEW OF PHASORS

- Physical voltage (or current), a real sinusoidal function of time

$$V(t) = V_0 \cos(\omega t + \phi)$$

- Phasor voltage (or current), a complex number, independent of time

$$\tilde{V} = V_0\, e^{j\phi} = V_R + jV_I$$

- Using $e^{j\phi} = \cos\phi + j\sin\phi$, we find

$$V_R = V_0 \cos\phi, \qquad V_I = V_0 \sin\phi$$

- Note that

$$\boxed{V(t) = \mathrm{Re}\left(\tilde{V}\, e^{j\omega t}\right)}$$

$$= V_0 \cos(\omega t + \phi)$$

$$= V_R \cos\omega t - V_I \sin\omega t$$

- Hence

$$V(t) \Longleftrightarrow \tilde{V} \qquad (\text{given } \omega)$$
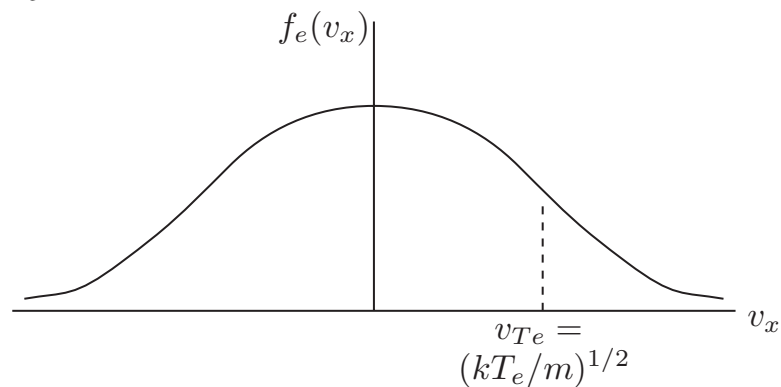
-17-

THERMAL EQUILIBRIUM PROPERTIES

- Electrons generally near thermal equilibrium

  Ions generally *not* in thermal equilibrium

- Maxwellian distribution of electrons

$$f_e(v) = n_e \left(\frac{m}{2\pi k T_e} \right)^{3/2} \exp \left(-\frac{mv^2}{2kT_e} \right)$$

where $v^2 = v_x^2 + v_y^2 + v_z^2$

- Pressure $p = nkT$

  For neutral gas at room temperature (300 K)

$$n_g(\text{cm}^{-3}) \approx 3.3 \times 10^{16} \, p(\text{Torr})$$
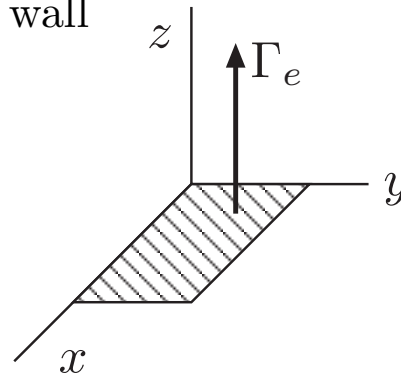
AVERAGES OVER MAXWELLIAN DISTRIBUTION

- Average energy

$$\langle \tfrac{1}{2}mv^2 \rangle = \tfrac{1}{n_e} \int d^3v \tfrac{1}{2}mv^2 f_e(v) = \tfrac{3}{2}kT_e$$

- Average speed

$$\bar{v}_e = \frac{1}{n_e} \int d^3v\, v f_e(v) = \boxed{\left(\frac{8kT_e}{\pi m}\right)^{1/2}}$$

- Average electron flux lost to a wall

$$\Gamma_e = \int_{-\infty}^{\infty} dv_x \int_{-\infty}^{\infty} dv_y \int_{0}^{\infty} dv_z v_z f_e(v) = \boxed{\frac{1}{4}n_e\bar{v}_e} \quad [\text{m}^{-2}\text{-s}^{-1}]$$

- Average kinetic energy lost per electron lost to a wall

$$\mathcal{E}_e = 2\,\mathrm{T}_e$$

FORCES ON PARTICLES

- For a unit volume of electrons (or ions),

$$mn_e \frac{d\mathbf{u}_e}{dt} = qn_e\mathbf{E} - \nabla p_e - mn_e\nu_m\mathbf{u}_e$$

  mass × acceleration = electric field force +

      + pressure gradient force + friction (gas drag) force

- m = electron mass

  n_e = electron density
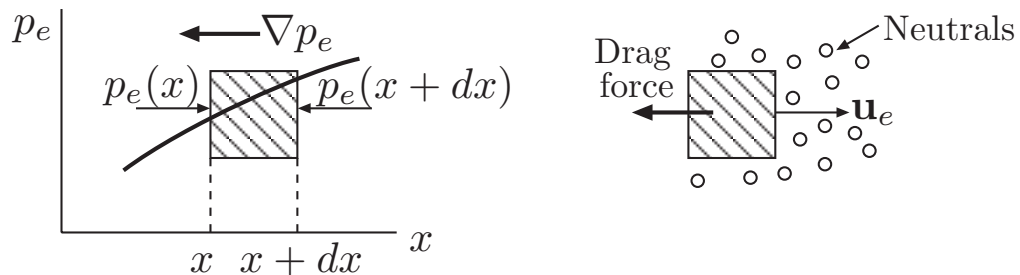
  $\mathbf{u}_e$ = electron flow velocity

  $q = -e$ for electrons ($+e$ for ions)

  $\mathbf{E}$ = electric field

  $p_e = n_e kT_e$ = electron pressure

  ν_m = collision frequency of electrons with neutrals

BOLTZMANN FACTOR FOR ELECTRONS

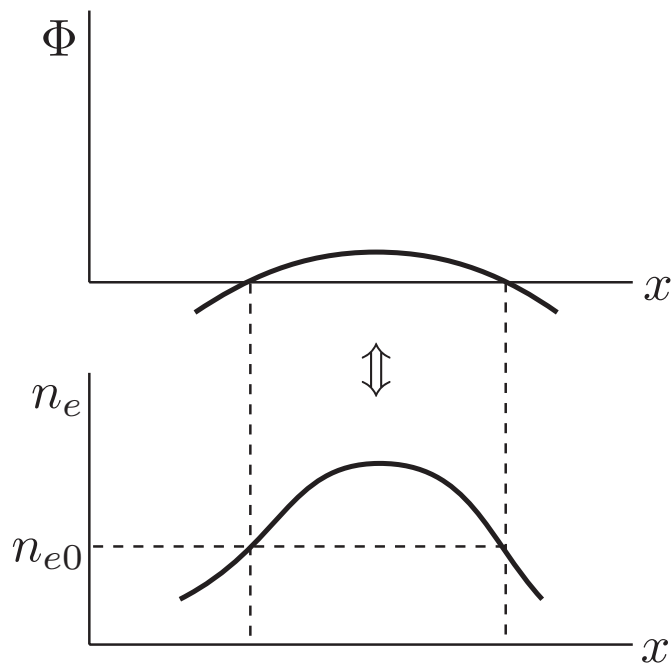- If electric field and pressure gradient forces almost balance:

$$0 \approx -en_e\mathbf{E} - \nabla p_e$$

- Let $\mathbf{E} = -\nabla\Phi$ and $p_e = n_e kT_e$:
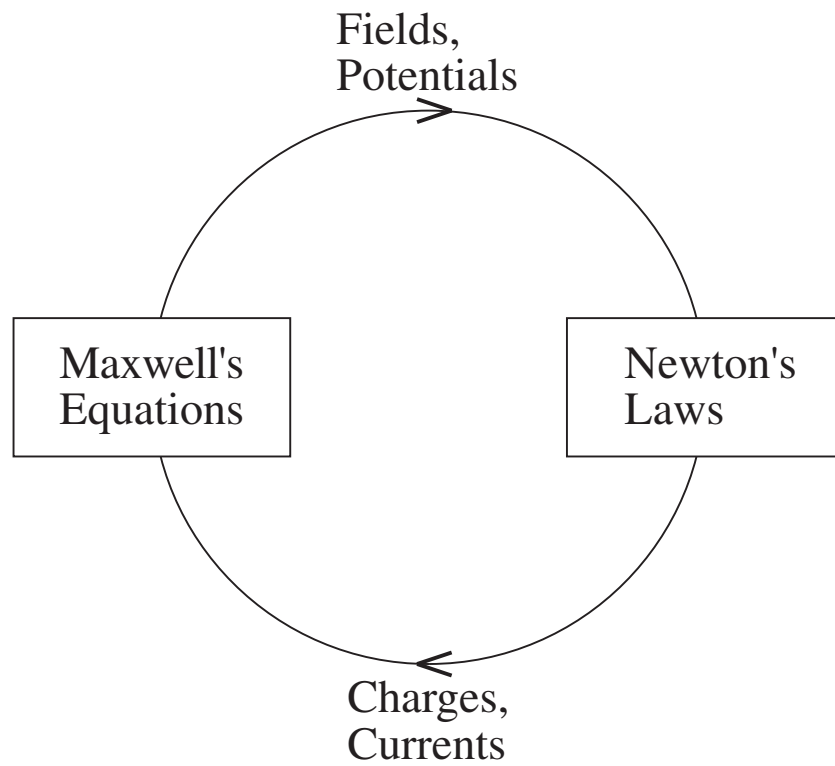
$$\nabla\Phi = \frac{kT_e}{e}\frac{\nabla n_e}{n_e}$$

- Put $kT_e/e = \mathrm{T}_e$ (volts) and integrate to obtain:

$$\boxed{n_e(\mathbf{r}) = n_{e0}\, \mathrm{e}^{\Phi(\mathbf{r})/\mathrm{T}_e}}$$

UNDERSTANDING PLASMA BEHAVIOR

- The field equations and the force equations are coupled

Fields,
Potentials

Maxwell's
Equations

Newton's
Laws

Charges,
Currents

DEBYE LENGTH $\lambda_{\mathbf{De}}$

- The characteristic length scale of a plasma

- Low voltage sheaths $\sim$ few Debye lengths thick

- Let's consider how a sheath forms near a wall:

  Electrons leave plasma before ions and charge wall negative
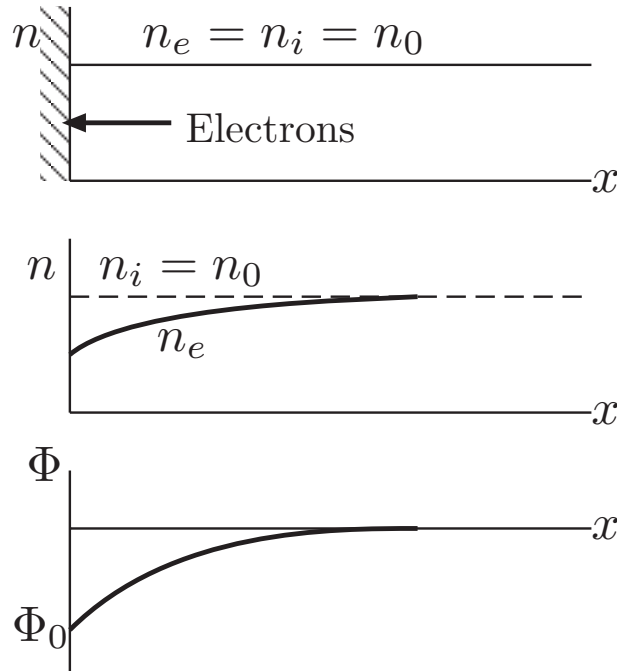
Assume electrons in thermal equilibrium and stationary ions

DEBYE LENGTH $\lambda_{\mathbf{De}}$ (CONT'D)

- Newton's laws

$$n_e(x) = n_0 \, e^{\Phi/T_e}, \qquad n_i = n_0$$

- Use in Poisson's equation

$$\frac{d^2\Phi}{dx^2} = -\frac{en_0}{\epsilon_0}\left(1 - e^{\Phi/T_e}\right)$$

- Linearize $e^{\Phi/T_e} \approx 1 + \Phi/T_e$

$$\frac{d^2\Phi}{dx^2} = \frac{en_0}{\epsilon_0 T_e}\Phi$$

- Solution is

$$\Phi(x) = \Phi_0 \, e^{-x/\lambda_{De}}, \qquad \boxed{\lambda_{De} = \left(\frac{\epsilon_0 T_e}{en_0}\right)^{1/2}}$$

- In practical units

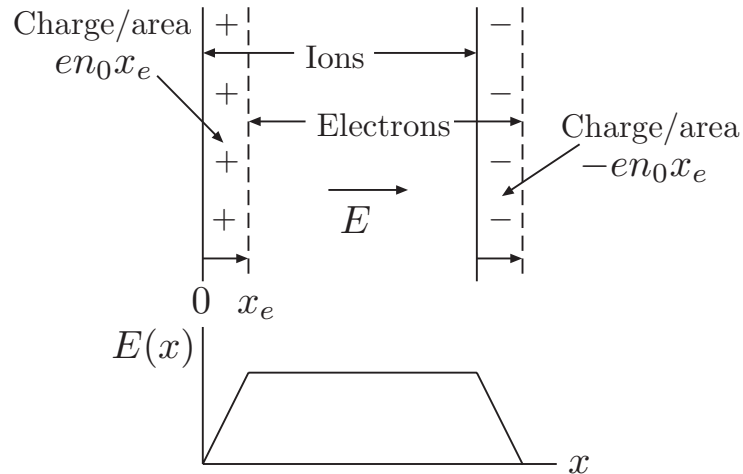$$\lambda_{De}(\text{cm}) = 740\sqrt{T_e/n_0}, \qquad T_e \text{ in volts, } n_0 \text{ in cm}^{-3}$$

- Example

  At $T_e = 1$ V and $n_0 = 10^{10}$ cm^{-3}, $\lambda_{De} = 7.4 \times 10^{-3}$ cm

  $\implies$ Sheath is ~ 0.15 mm thick (Very thin!)

ELECTRON PLASMA FREQUENCY $\omega_{\mathbf{pe}}$

- The fundamental timescale for a plasma

- Consider a plasma slab (no walls). Displace all electrons to the right a small distance x_{e0}, and release them:

- Maxwell's equations (parallel plate capacitor)

$$E = \frac{en_0 x_e(t)}{\epsilon_0}$$

- Newton's laws (electron motion)

$$m\frac{d^2 x_e(t)}{dt^2} = -\frac{e^2 n_0}{\epsilon_0}x_e(t)$$

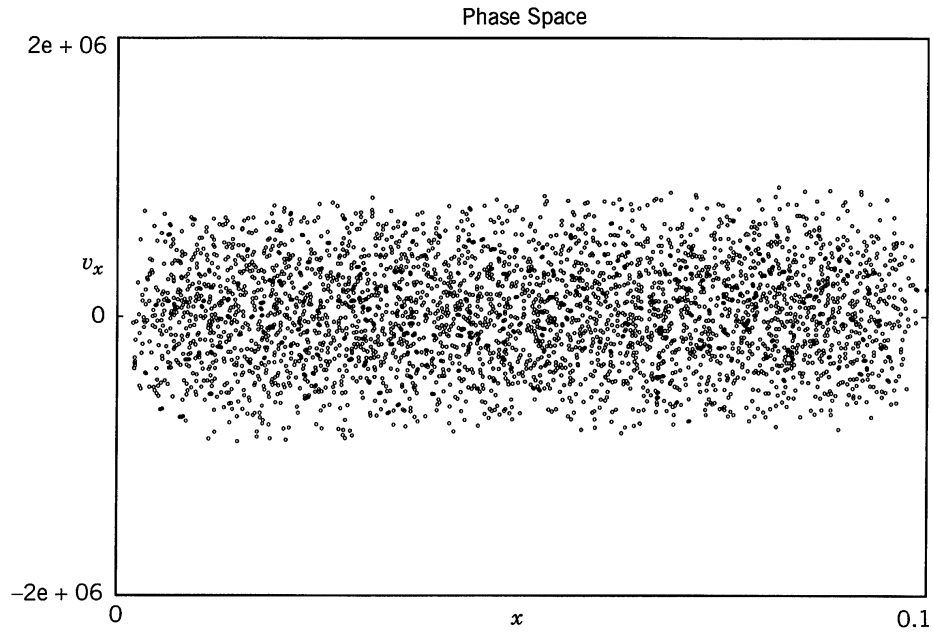- Solution is electron plasma oscillations

$$x_e(t) = x_{e0}\cos\omega_{pe}t, \qquad \boxed{\omega_{pe} = \left(\frac{e^2 n_0}{\epsilon_0 m}\right)^{1/2}}$$

- Practical formula is $f_{pe}(\text{Hz}) = 9000\sqrt{n_0}, \quad n_0$ in cm^{-3}

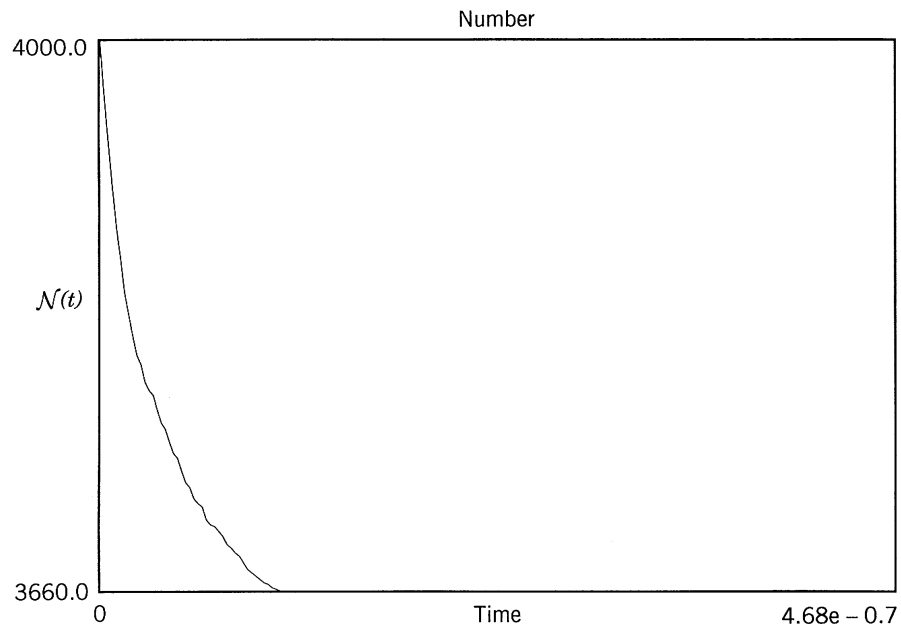 $\implies$ microwave frequencies ($\gtrsim 1$ GHz) for typical plasmas

1D SIMULATION OF SHEATH FORMATION

$$(\text{T}_e = 1 \text{ V}, \; n_e = n_i = 10^{13} \text{ m}^{-3})$$

- Electron v_x–x phase space at $t = 0.77 \; \mu$s
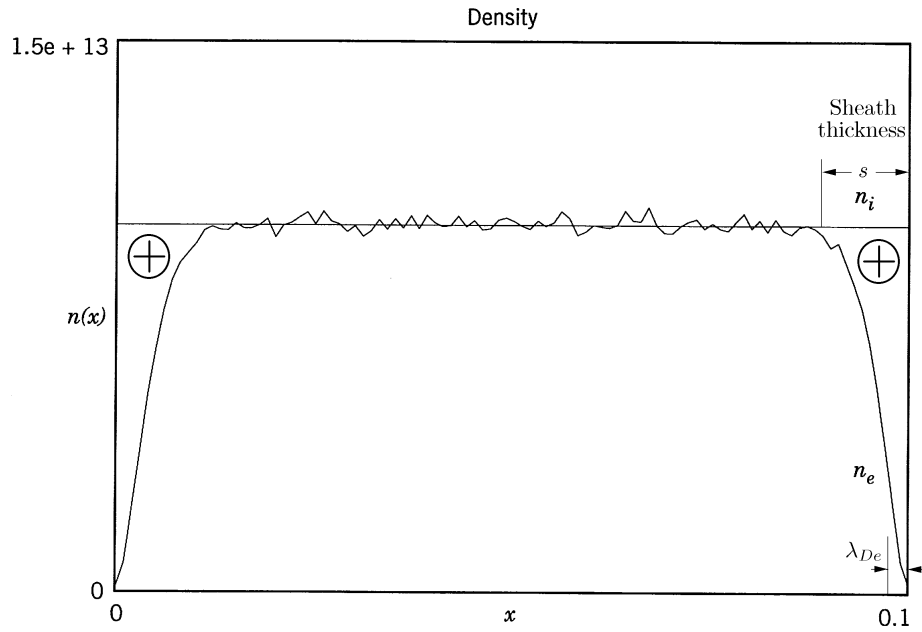

Phase Space

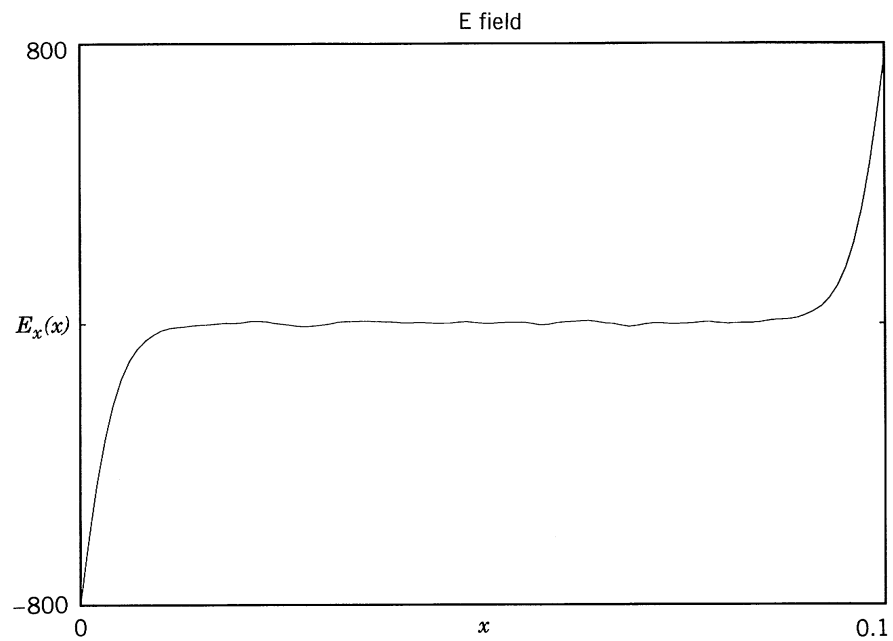- Electron number $\mathcal{N}$ versus t

Number

-26-

1D SIMULATION OF SHEATH FORMATION (CONT'D)

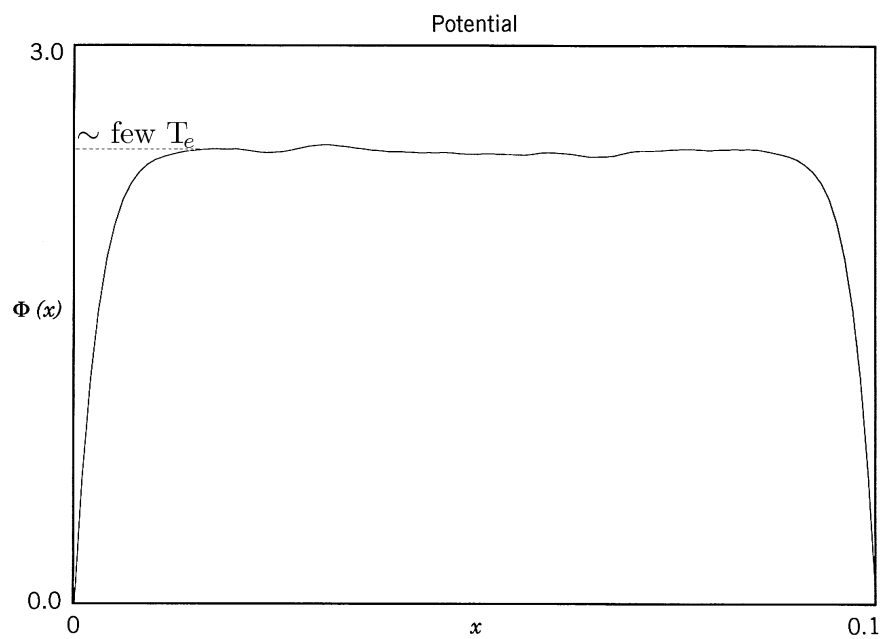- Electron density $n_e(x)$ at $t = 0.77~\mu$s
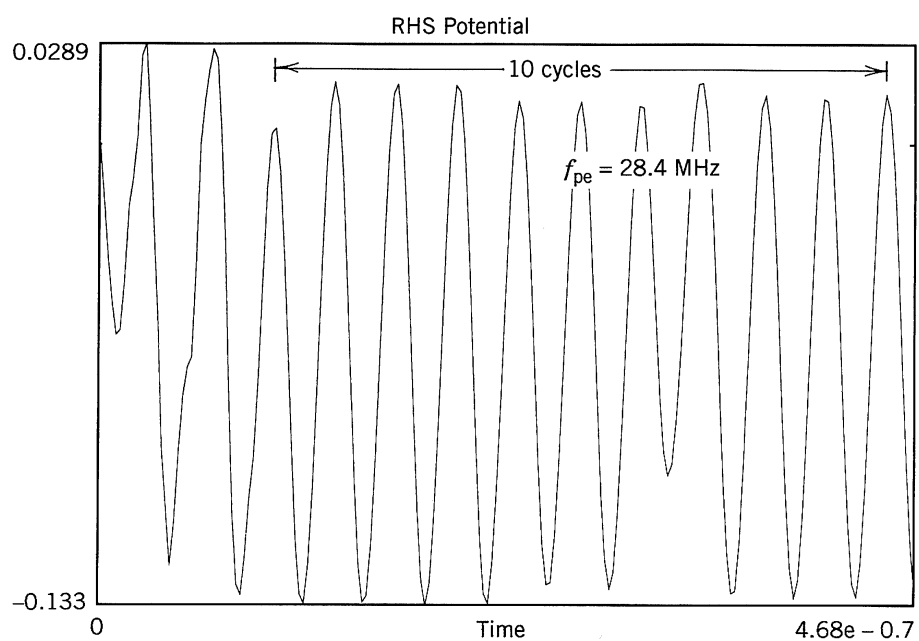

- Electric field $E(x)$ at $t = 0.77~\mu$s

1D SIMULATION OF SHEATH FORMATION (CONT'D)

- Potential $\Phi(x)$ at $t = 0.77 \ \mu s$

- Right hand potential $\Phi(x = l)$ versus t

PLASMA DIELECTRIC CONSTANT $\epsilon_{\mathbf{p}}$

- RF discharges are driven at a frequency ω

$$E(t) = \mathrm{Re}\,(\tilde{E}\,\mathrm{e}^{j\omega t}), \quad \text{etc}$$

- Define ϵ_p from the total current in Maxwell's equations

$$\nabla \times \tilde{H} = \underbrace{\tilde{J}_c + j\omega\epsilon_0\tilde{E}}_{\text{Total current } \tilde{J}} \equiv j\omega\epsilon_p\tilde{E}$$

- Conduction current $\tilde{J}_c = -en_e\tilde{u}_e$ is mainly due to electrons
- Newton's law (electric field and neutral drag) is

$$j\omega m\tilde{u}_e = -e\tilde{E} - m\nu_m\tilde{u}_e$$

- Solve for $\tilde{u}_e$ and evaluate $\tilde{J}_c$ to obtain

$$\boxed{\epsilon_p = \epsilon_0 \left[1 - \frac{\omega_{pe}^2}{\omega(\omega - j\nu_m)} \right]}$$

- For $\omega \gg \nu_m$, ϵ_p is mainly real (nearly lossless dielectric)

  For $\nu_m \gg \omega$, ϵ_p is mainly imaginary (very lossy dielectric)
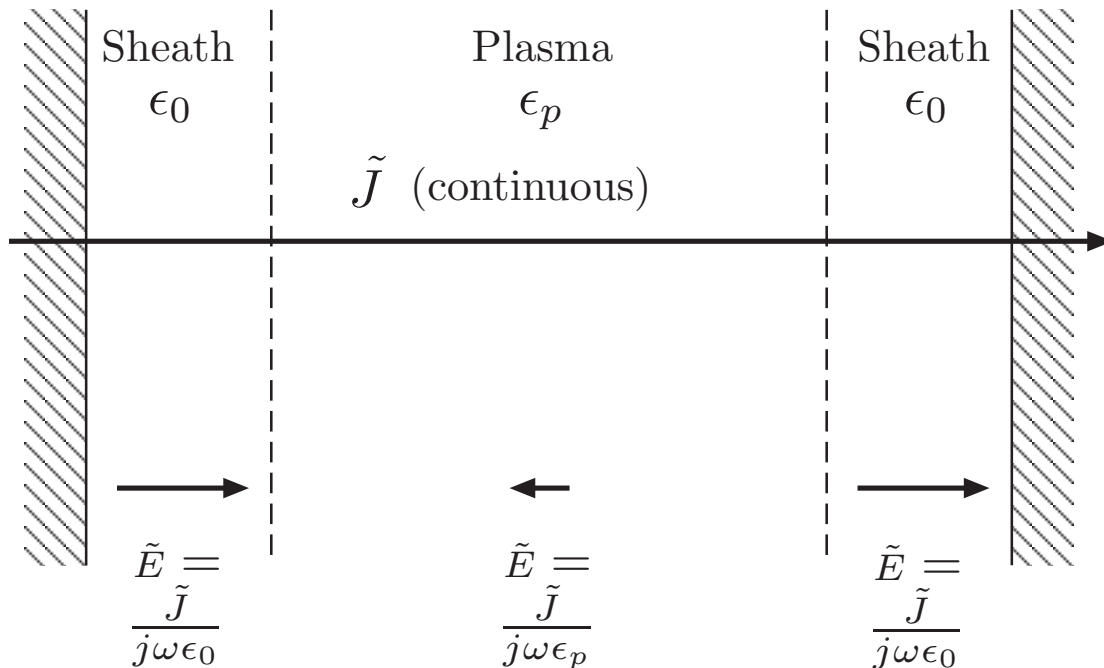
RF FIELDS IN LOW PRESSURE DISCHARGES

- Consider mainly lossless plasma $(\omega \gg \nu_m)$

$$\boxed{\epsilon_p = \epsilon_0 \left(1 - \frac{\omega_{pe}^2}{\omega^2} \right)}$$

- For almost all RF discharges, $\omega_{pe} \gg \omega$

$$\implies \epsilon_p \text{ is negative}$$

- Typical case: $\epsilon_p = -1000 \, \epsilon_0$

Sheath ϵ_0	Plasma ϵ_p	Sheath ϵ_0
	$\tilde{J}$ (continuous)	
$\tilde{E} = \dfrac{\tilde{J}}{j\omega\epsilon_0}$	$\tilde{E} = \dfrac{\tilde{J}}{j\omega\epsilon_p}$	$\tilde{E} = \dfrac{\tilde{J}}{j\omega\epsilon_0}$

- Electric field in plasma is $1000 \times$ smaller than in sheaths!

- Although field in plasma is small, it sustains the plasma!

PLASMA CONDUCTIVITY $\sigma_{\mathbf{p}}$

- Useful to introduce the plasma conductivity $\tilde{J}_c \equiv \sigma_p \tilde{E}$

- RF plasma conductivity

$$\sigma_p = \frac{e^2 n_e}{m(\nu_m + j\omega)}$$

- DC plasma conductivity $(\omega \ll \nu_m)$

$$\boxed{\sigma_{\mathrm{dc}} = \frac{e^2 n_e}{m\nu_m}}$$

- The plasma dielectric constant and conductivity are related by:

$$j\omega\epsilon_p = \sigma_p + j\omega\epsilon_0$$

- Due to σ_p, rf current flowing through the plasma heats electrons (just like a resistor)

OHMIC HEATING POWER

- Time average power absorbed/volume

$$p_d = \langle \mathbf{J}(t) \cdot \mathbf{E}(t) \rangle = \frac{1}{2} \operatorname{Re}(\tilde{J} \cdot \tilde{E}^*) \qquad [\mathrm{W/m^3}]$$

- Put $\tilde{J} = (\sigma_p + j\omega\epsilon_0)\tilde{E}$ to find p_d in terms of $\tilde{E}$

$$p_d = \frac{1}{2}|\tilde{E}|^2 \sigma_{\mathrm{dc}} \frac{\nu_m^2}{\omega^2 + \nu_m^2}$$

- Put $\tilde{E} = \tilde{J}/(\sigma_p + j\omega\epsilon_0)$ to find p_d in terms of $\tilde{J}$.

  For almost all rf discharges $(\omega_{pe} \gg \omega)$

$$\boxed{p_d = \frac{1}{2}|\tilde{J}|^2 \frac{1}{\sigma_{\mathrm{dc}}}}$$
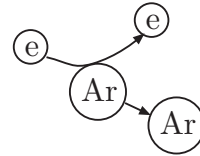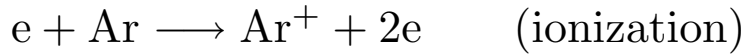
SUMMARY OF DISCHARGE FUNDAMENTALS

ELECTRON COLLISIONS WITH ARGON

- Maxwellian electrons collide with Ar atoms (density n_g)

$$\frac{dn_e}{dt} = \nu n_e = K n_g\, n_e$$

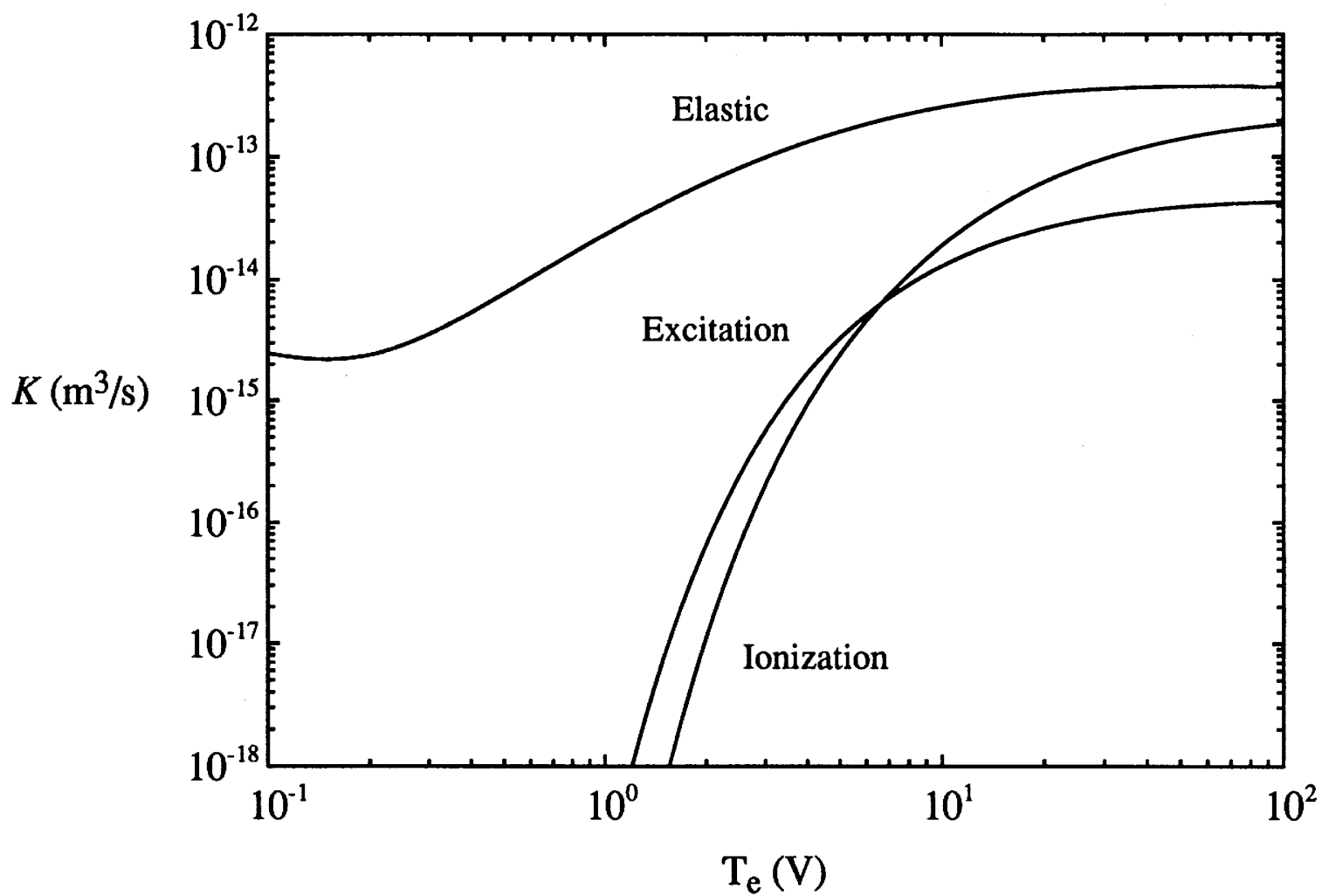 ν = collision frequency [s^{-1}], $K(T_e)$ = rate coefficient [m^3/s]

- Electron-Ar collision processes

  $e + Ar \longrightarrow Ar^+ + 2e \qquad$ (ionization)

  $e + Ar \longrightarrow e + Ar^* \longrightarrow e + Ar + $ photon $\qquad$ (excitation)

  $e + Ar \longrightarrow e + Ar \qquad$ (elastic scattering)

- Rate coefficient $K(T_e)$ is average of cross section σ [m^2] for process, over Maxwellian distribution
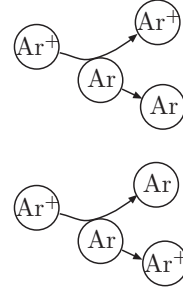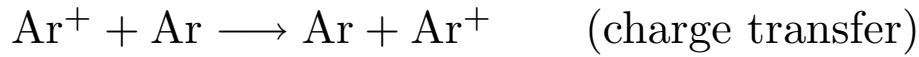
$$K(T_e) = \langle \sigma v \rangle_{\text{Maxwellian}}$$

ELECTRON-ARGON RATE COEFFICIENTS

ION COLLISIONS WITH ARGON

- Argon ions collide with Ar atoms

  $$Ar^+ + Ar \longrightarrow Ar^+ + Ar \qquad \text{(elastic scattering)}$$

  $$Ar^+ + Ar \longrightarrow Ar + Ar^+ \qquad \text{(charge transfer)}$$

- Total cross section for room temperature ions $\sigma_i \approx 10^{-14}$ cm^2

- Ion-neutral mean free path

$$\lambda_i = \frac{1}{n_g \sigma_i}$$

- Practical formula

$$\lambda_i(\text{cm}) = \frac{1}{330\,p}, \qquad p \text{ in Torr}$$

- Rate coefficient for ion-neutral collisions

$$K_i = \frac{\bar{v}_i}{\lambda_i}$$

with $\bar{v}_i = (8kT_i/\pi M)^{1/2}$

THREE ENERGY LOSS PROCESSES

1. Collisional energy $\mathcal{E}_c$ lost per electron-ion pair created

$$K_{\text{iz}}\mathcal{E}_c = K_{\text{iz}}\mathcal{E}_{\text{iz}} + K_{\text{ex}}\mathcal{E}_{\text{ex}} + K_{\text{el}}(2m/M)(3\text{T}_e/2)$$

$$\Longrightarrow \mathcal{E}_c(\text{T}_e) \qquad \text{(voltage units)}$$

   $\mathcal{E}_{\text{iz}}$, $\mathcal{E}_{\text{ex}}$, and $(3m/M)\text{T}_e$ are energies lost by an electron due to an ionization, excitation, and elastic scattering collision

2. Electron kinetic energy lost to walls
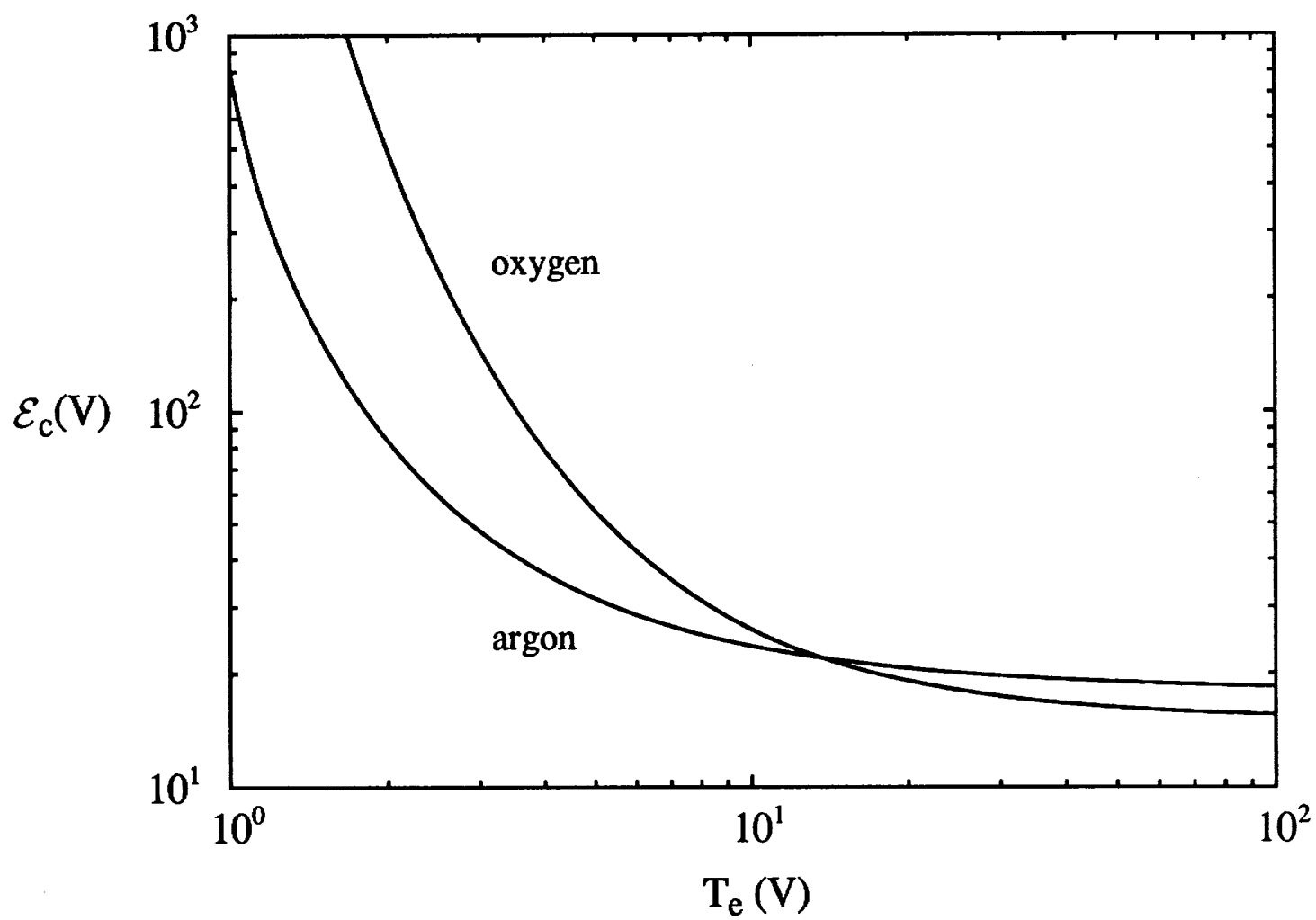
$$\mathcal{E}_e = 2\,\text{T}_e$$

3. Ion kinetic energy lost to walls is mainly due to the dc potential $\bar{V}_s$ across the sheath
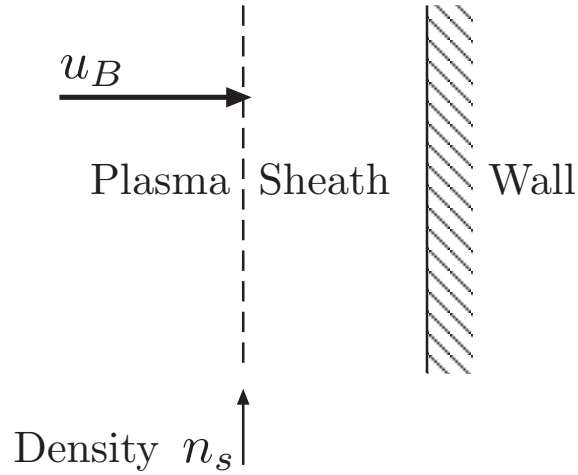
$$\mathcal{E}_i \approx \bar{V}_s$$

- Total energy lost per electron-ion pair lost to walls

$$\boxed{\mathcal{E}_T = \mathcal{E}_c + \mathcal{E}_e + \mathcal{E}_i}$$

COLLISIONAL ENERGY LOSSES

BOHM (ION LOSS) VELOCITY u_B

- Due to formation of a "presheath", ions arrive at the plasma-sheath edge with directed energy $kT_e/2$

$$\frac{1}{2}Mu_i^2 = \frac{kT_e}{2}$$

- At the plasma-sheath edge (density n_s), electron-ion pairs are lost at the Bohm velocity
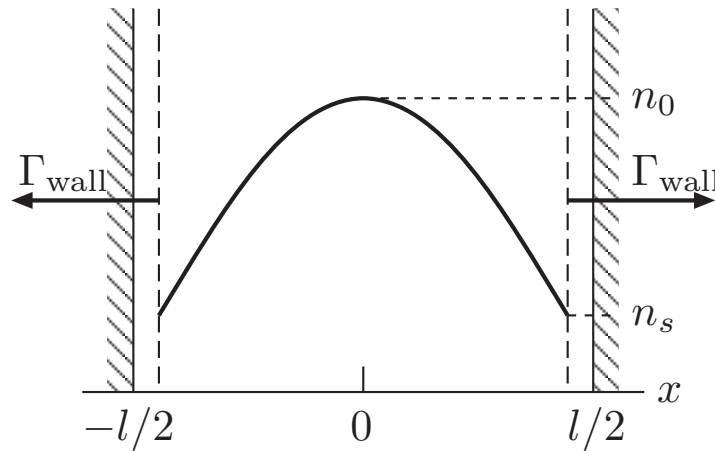
$$\boxed{u_i = u_B = \left(\frac{kT_e}{M}\right)^{1/2}}$$

AMBIPOLAR DIFFUSION AT HIGH PRESSURES

- Plasma bulk is quasi-neutral ($n_e \approx n_i = n$) and the electron and ion loss fluxes are equal ($\Gamma_e \approx \Gamma_i \approx \Gamma$)

- Fick's law

$$\Gamma = -D_a \nabla n$$

with ambipolar diffusion coefficient $D_a = kT_e/M\nu_i$

- Density profile is sinusoidal

- Loss flux to the wall is
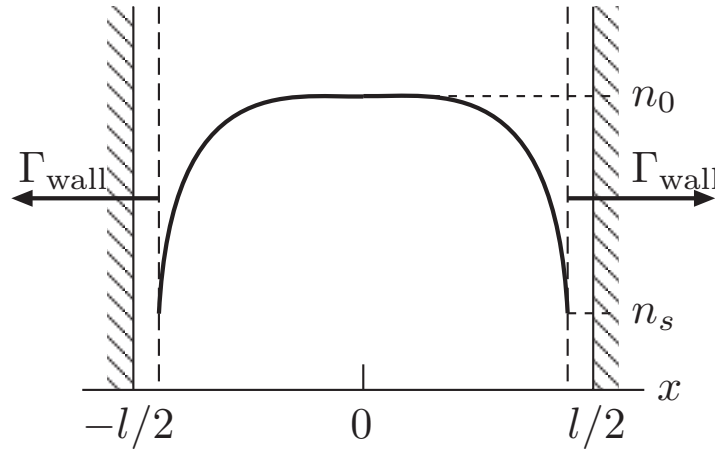
$$\Gamma_{\text{wall}} = h_l n_0 u_B$$

where the edge-to-center density ratio is

$$h_l \equiv \frac{n_s}{n_0} = \frac{\pi}{l} \frac{u_B}{\nu_i}$$

- Applies for pressures > 100 mTorr in argon

AMBIPOLAR DIFFUSION AT LOW PRESSURES

- The diffusion coefficient is not constant

- Density profile is relatively flat in the center and falls sharply near the sheath edge

- For a cylindrical plasma of length l and radius R, loss fluxes to axial and radial walls are

$$\Gamma_{\text{axial}} = h_l n_0 u_B, \qquad \Gamma_{\text{radial}} = h_R n_0 u_B$$
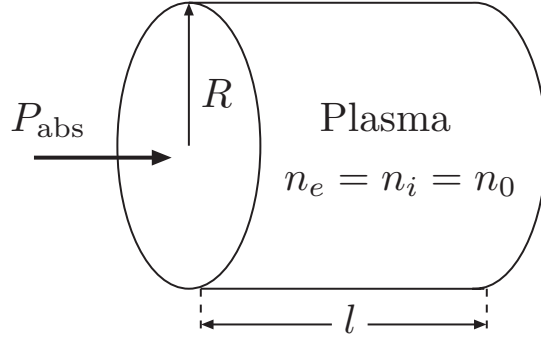
where the edge-to-center density ratios are

$$h_l \approx \frac{0.86}{(3 + l/2\lambda_i)^{1/2}}, \qquad h_R \approx \frac{0.8}{(4 + R/\lambda_i)^{1/2}}$$

- Applies for pressures $<$ 100 mTorr in argon

ANALYSIS OF DISCHARGE EQUILIBRIUM

PARTICLE BALANCE AND T_e

- Assume uniform cylindrical plasma absorbing power P_{abs}

- Particle balance

    Production due to ionization = loss to the walls

$$\boxed{K_{iz}n_gn_0\pi R^2l = (2\pi R^2h_ln_0 + 2\pi Rlh_Rn_0)u_B}$$

- Solve to obtain

$$\frac{K_{iz}(T_e)}{u_B(T_e)} = \frac{1}{n_gd_{eff}}$$

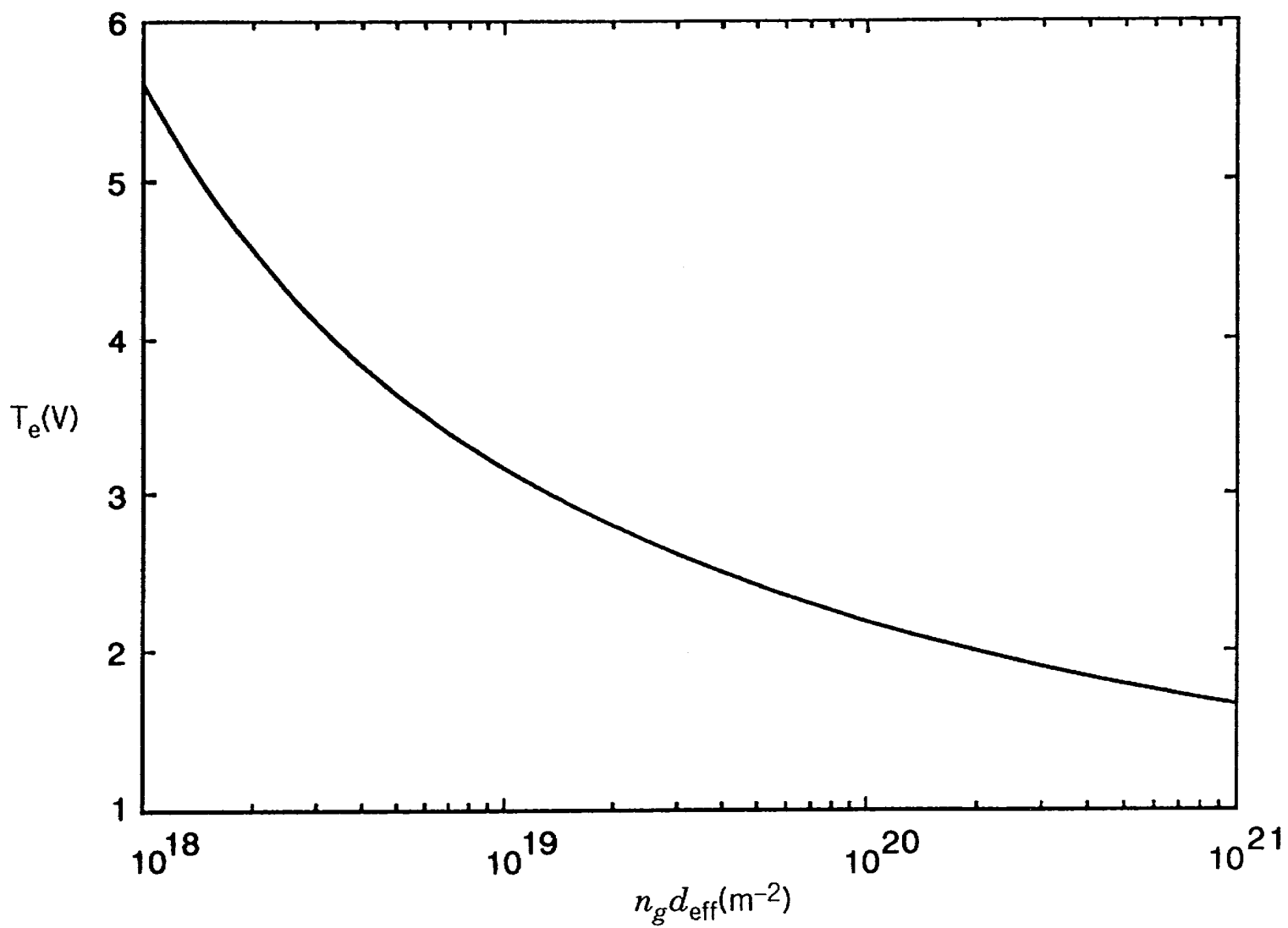   where

$$d_{eff} = \frac{1}{2}\frac{Rl}{Rh_l + lh_R}$$

    is an effective plasma size

- Given n_g and $d_{eff} \implies$ electron temperature T_e
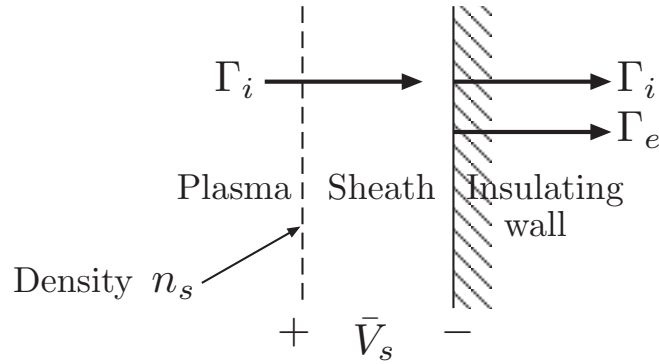
- T_e varies over a narrow range of 2–5 volts

ELECTRON TEMPERATURE IN ARGON DISCHARGE

ION ENERGY FOR LOW VOLTAGE SHEATHS

- $\mathcal{E}_i$ = energy entering sheath + energy gained traversing sheath

- Ion energy entering sheath = $T_e/2$ (voltage units)

- Sheath voltage determined from particle conservation in the sheath

$$\Gamma_i = n_s u_B, \qquad \Gamma_e = \frac{1}{4} n_s \bar{v}_e \, e^{-\bar{V}_s/T_e}$$

with $\bar{v}_e = (8eT_e/\pi m)^{1/2}$

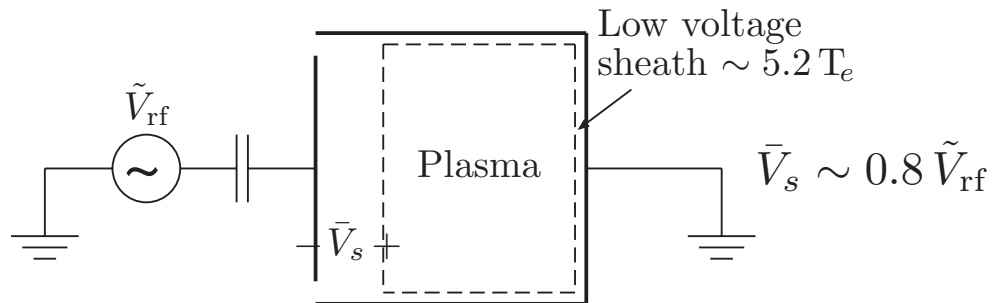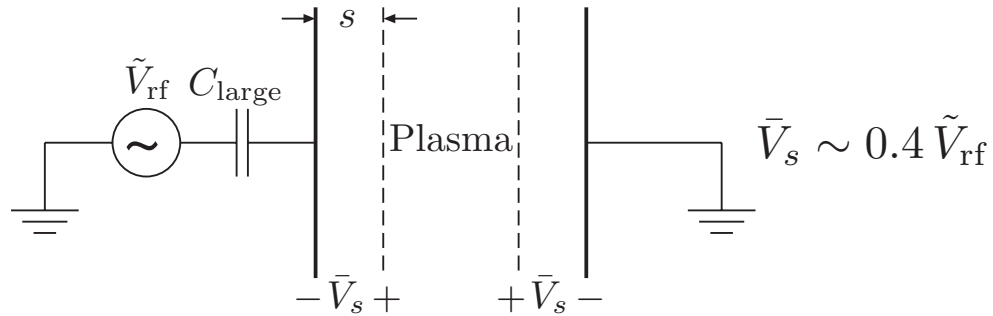- The ion and electron fluxes must balance

$$\boxed{\bar{V}_s = \frac{T_e}{2} \ln\left(\frac{M}{2\pi m}\right)}$$

or $\bar{V}_s \approx 4.7\,T_e$ for argon

- Accounting for the initial ion energy, $\mathcal{E}_i \approx 5.2\,T_e$

ION ENERGY FOR HIGH VOLTAGE SHEATHS

- Large ion bombarding energies can be gained near rf-driven electrodes embedded in the plasma

- The sheath thickness s is given by the Child Law

$$\bar{J}_i = en_s u_B = \frac{4}{9}\epsilon_0 \left(\frac{2e}{M}\right)^{1/2} \frac{\bar{V}_s^{3/2}}{s^2}$$

- Estimating ion energy is not simple as it depends on the type of discharge and the application of bias voltages

POWER BALANCE AND n_0

- Assume low voltage sheaths at all surfaces

$$\mathcal{E}_T(\mathrm{T}_e) \; = \; \underbrace{\mathcal{E}_c(\mathrm{T}_e)}_{\text{Collisional}} \; + \; \underbrace{2\,\mathrm{T}_e}_{\text{Electron}} \; + \; \underbrace{5.2\,\mathrm{T}_e}_{\text{Ion}}$$

- Power balance

$$\text{Power in} = \text{power out}$$

$$\boxed{P_{\text{abs}} = \left(h_l n_0 2\pi R^2 + h_R n_0 2\pi R l\right) u_B\, e\mathcal{E}_T}$$

- Solve to obtain

$$n_0 = \frac{P_{\text{abs}}}{A_{\text{eff}} u_B e\mathcal{E}_T}$$

where

$$A_{\text{eff}} = 2\pi R^2 h_l + 2\pi R l h_R$$

is an effective area for particle loss

- Density n_0 is proportional to the absorbed power P_{abs}

- Density n_0 depends on pressure p through h_l, h_R, and T_e

PARTICLE AND POWER BALANCE

- Particle balance $\Longrightarrow$ electron temperature T_e

  (independent of plasma density)

- Power balance $\Longrightarrow$ plasma density n_0

  (once electron temperature T_e is known)

EXAMPLE 1

- Let $R = 0.15$ m, $l = 0.3$ m, $n_g = 3.3 \times 10^{19}$ m^{-3} ($p = 1$ mTorr at 300 K), and $P_{\text{abs}} = 800$ W

- Assume low voltage sheaths at all surfaces

- Find $\lambda_i = 0.03$ m. Then $h_l \approx h_R \approx 0.3$ and $d_{\text{eff}} \approx 0.17$ m

- From the T$_e$ versus $n_g d_{\text{eff}}$ figure, T$_e \approx 3.5$ V

- From the $\mathcal{E}_c$ versus T$_e$ figure, $\mathcal{E}_c \approx 42$ V. Adding $\mathcal{E}_e = 2$T$_e \approx 7$ V and $\mathcal{E}_i \approx 5.2T_e \approx 18$ V yields $\mathcal{E}_T = 67$ V

- Find $u_B \approx 2.9 \times 10^3$ m/s and find $A_{\text{eff}} \approx 0.13$ m^2

- Power balance yields $n_0 \approx 2.0 \times 10^{17}$ m^{-3}

- Ion current density $J_{il} = e h_l n_0 u_B \approx 2.9$ mA/cm^2

- Ion bombarding energy $\mathcal{E}_i \approx 18$ V

EXAMPLE 2

- Apply a strong dc magnetic field along the cylinder axis

  $\Longrightarrow$ particle loss to radial wall is inhibited

- For no radial loss, $d_{\text{eff}} = l/2h_l \approx 0.5$ m

- From the T_e versus $n_g d_{\text{eff}}$ figure, $T_e \approx 3.3$ V

- From the $\mathcal{E}_c$ versus T_e figure, $\mathcal{E}_c \approx 46$ V. Adding $\mathcal{E}_e = 2T_e \approx$ 6.6 V and $\mathcal{E}_i \approx 5.2T_e \approx 17$ V yields $\mathcal{E}_T = 70$ V

- Find $u_B \approx 2.8 \times 10^3$ m/s and find $A_{\text{eff}} = 2\pi R^2 h_l \approx 0.043$ m^2

- Power balance yields $n_0 \approx 5.8 \times 10^{17}$ m^{-3}

- Ion current density $J_{il} = e h_l n_0 u_B \approx 7.8$ mA/cm^2

- Ion bombarding energy $\mathcal{E}_i \approx 17$ V

  $\Longrightarrow$ Significant increase in plasma density n_0

ELECTRON HEATING MECHANISMS

- Discharges can be distinguished by electron heating mechanisms

(a) Ohmic (collisional) heating (capacitive, inductive discharges)

(b) Stochastic (collisionless) heating (capacitive, inductive discharges)

(c) Resonant wave-particle interaction heating (Electron cyclotron resonance and helicon discharges)

- Achieving adequate electron heating is a central issue

- Although the heated electrons provide the ionization required to sustain the discharge, the electrons tend to short out the applied heating fields within the bulk plasma
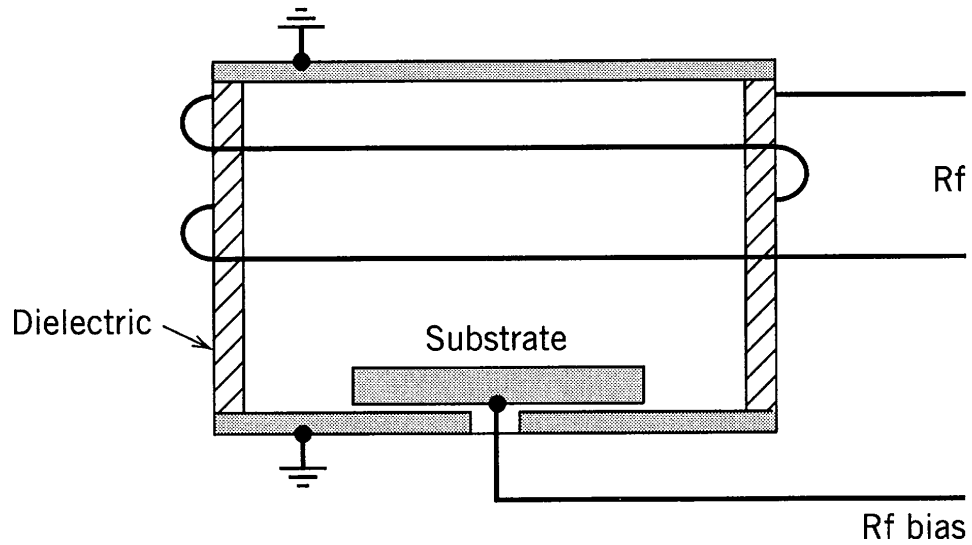
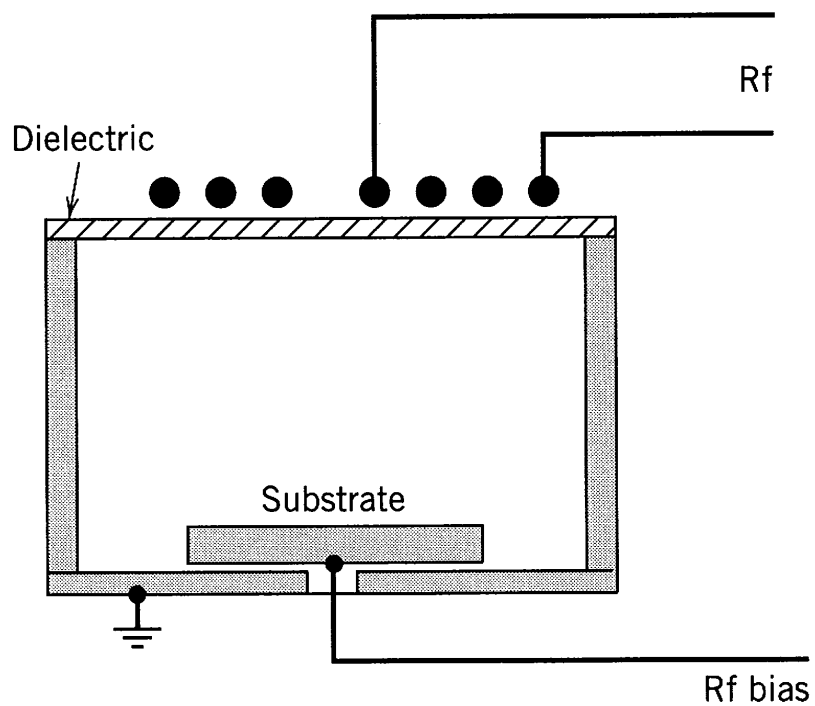# INDUCTIVE DISCHARGES

DESCRIPTION AND MODEL

MOTIVATION

- Independent control of plasma density and ion energy

- Simplicity of concept

- RF rather than microwave powered

- No source magnetic fields

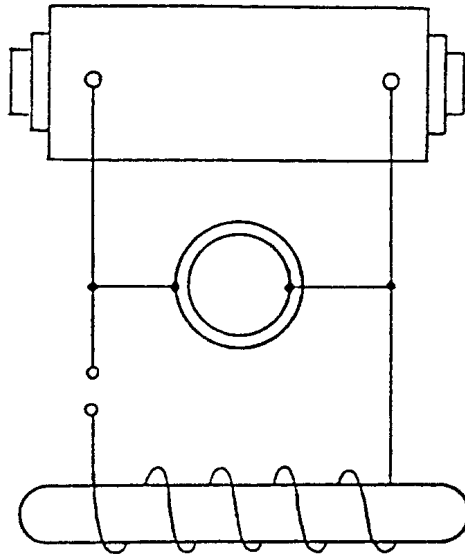# CYLINDRICAL AND PLANAR CONFIGURATIONS

- Cylindrical coil

- Planar coil
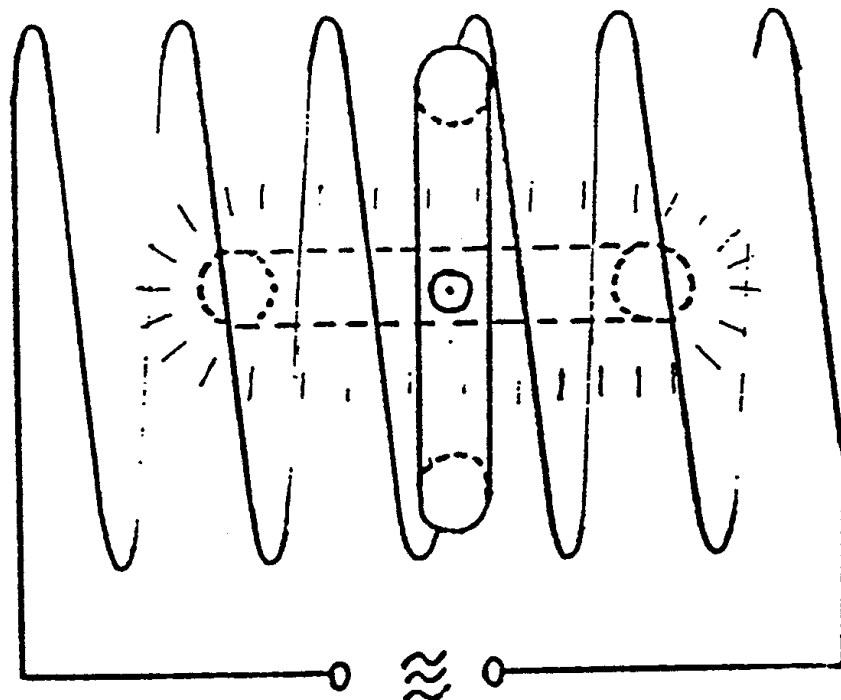
EARLY HISTORY

- First inductive discharge by Hittorf (1884)
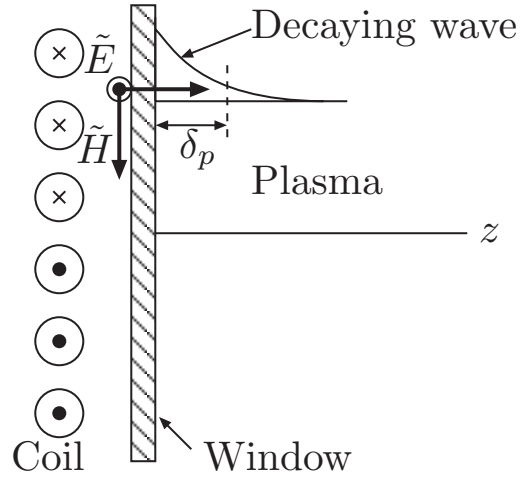

- Arrangement to test discharge mechanism by Lehmann (1892)

HIGH DENSITY REGIME

- Inductive coil launches electromagnetic wave into plasma

- Wave decays exponentially into plasma

$$\tilde{E} = \tilde{E}_0 \, e^{-z/\delta_p}, \qquad \delta_p = \frac{c}{\omega} \frac{1}{\text{Im}(\kappa_p^{1/2})}$$
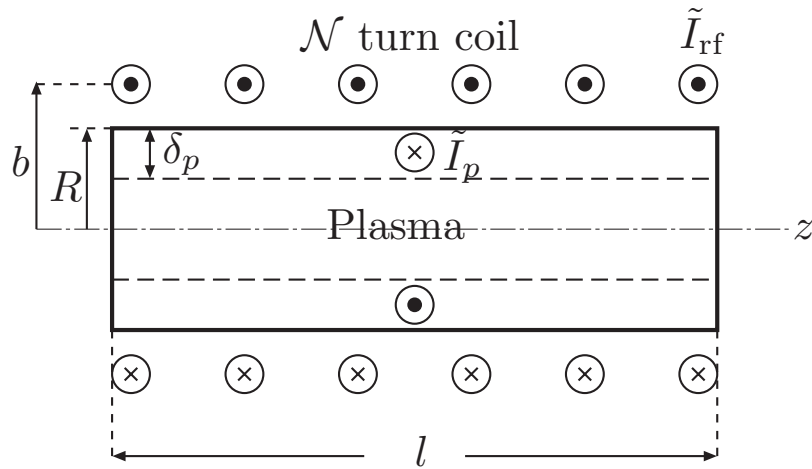
where κ_p = plasma dielectric constant

$$\kappa_p = 1 - \frac{\omega_{pe}^2}{\omega(\omega - j\nu_m)}$$

For typical high density, low pressure $(\nu_m \ll \omega)$ discharge

$$\delta_p \approx \frac{c}{\omega_{pe}} = \left(\frac{m}{e^2 \mu_0 n_e} \right)^{1/2} \sim \; 1\text{--}2 \text{ cm}$$

TRANSFORMER MODEL

- For simplicity consider long cylindrical discharge

- Current $\tilde{I}_{\mathrm{rf}}$ in $\mathcal{N}$ turn coil induces current $\tilde{I}_p$ in 1-turn plasma skin

$$\boxed{\Longrightarrow \text{ A transformer}}$$

PLASMA RESISTANCE AND INDUCTANCE

- Plasma resistance R_p

$$R_p = \frac{1}{\sigma_{\text{dc}}} \frac{\text{circumference of plasma loop}}{\text{cross sectional area of loop}}$$

where

$$\sigma_{\text{dc}} = \frac{e^2 n_{es}}{m \nu_m}$$

$$\boxed{\Longrightarrow R_p = \frac{2\pi R}{\sigma_{\text{dc}} l \delta_p}}$$

- Plasma inductance L_p

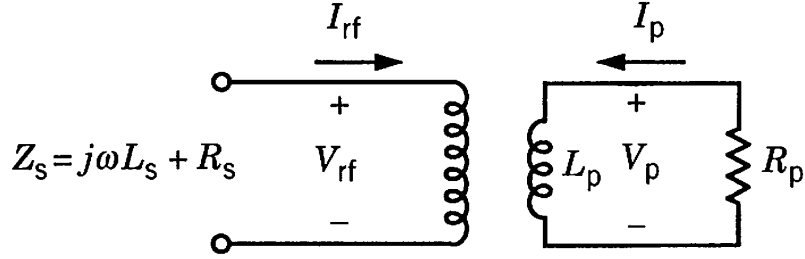$$L_p = \frac{\text{magnetic flux produced by plasma current}}{\text{plasma current}}$$

- Using magnetic flux $= \pi R^2 \mu_0 \tilde{I}_p / l$

$$\boxed{\Longrightarrow L_p = \frac{\mu_0 \pi R^2}{l}}$$

COUPLING OF PLASMA AND COIL

- Model the source as a transformer

$$\tilde{V}_{\mathrm{rf}} = j\omega L_{11}\tilde{I}_{\mathrm{rf}} + j\omega L_{12}\tilde{I}_p$$

$$\tilde{V}_p = j\omega L_{21}\tilde{I}_{\mathrm{rf}} + j\omega L_{22}\tilde{I}_p$$

- Transformer inductances

$$L_{11} = \frac{\text{magnetic flux linking coil}}{\text{coil current}} = \frac{\mu_0 \pi b^2 \mathcal{N}^2}{l}$$

$$L_{12} = L_{21} = \frac{\text{magnetic flux linking plasma}}{\text{coil current}} = \frac{\mu_0 \pi R^2 \mathcal{N}}{l}$$

$$L_{22} = L_p = \frac{\mu_0 \pi R^2}{l}$$

- Put $\tilde{V}_p = -\tilde{I}_p R_p$ in transformer equations and solve for impedance $Z_s = \tilde{V}_{\mathrm{rf}}/\tilde{I}_{\mathrm{rf}}$ seen at coil terminals

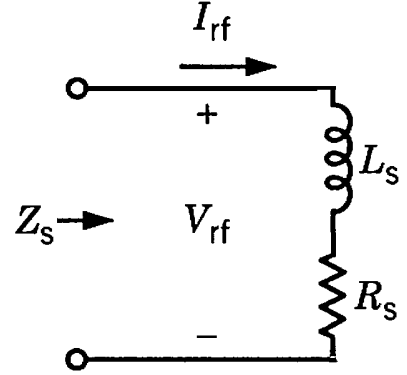$$\boxed{Z_s = j\omega L_{11} + \frac{\omega^2 L_{12}^2}{R_p + j\omega L_p}}$$

SOURCE CURRENT AND VOLTAGE

- Equivalent circuit at coil terminals

$$Z_s = R_s + j\omega L_s$$

$$R_s = \mathcal{N}^2 \frac{2\pi R}{\sigma_{\mathrm{dc}} l \delta_p}$$

$$L_s = \frac{\mu_0 \pi R^2 \mathcal{N}^2}{l} \left(\frac{b^2}{R^2} - 1 \right)$$

- Power balance $\Longrightarrow \tilde{I}_{\mathrm{rf}}$

$$P_{\mathrm{abs}} = \frac{1}{2} \tilde{I}_{\mathrm{rf}}^2 R_s$$

- From source impedance $\Longrightarrow V_{\mathrm{rf}}$

$$\tilde{V}_{\mathrm{rf}} = \tilde{I}_{\mathrm{rf}} Z_s$$

EXAMPLE

- Assume plasma radius $R = 10$ cm, coil radius $b = 15$ cm, length $l = 20$ cm, $\mathcal{N} = 3$ turns, gas density $n_g = 1.7 \times 10^{14}$ cm^{-3} (5 mTorr argon at 300 K), $\omega = 85 \times 10^6$ s^{-1} (13.56 MHz), absorbed power $P_{\text{abs}} = 600$ W, and low voltage sheaths

- At 5 mTorr, $\lambda_i \approx 0.6$ cm, $h_l \approx h_R \approx 0.19$, and $d_{\text{eff}} \approx 17.9$ cm

- Particle balance (T$_e$ versus $n_g d_{\text{eff}}$ figure) yields T$_e \approx 2.6$ V

- Collisional energy losses ($\mathcal{E}_c$ versus T$_e$ figure) are $\mathcal{E}_c \approx 58$ V
  Adding $\mathcal{E}_e + \mathcal{E}_i = 7.2\,\text{T}_e$ yields total energy losses $\mathcal{E}_T \approx 77$ V

- $u_B \approx 2.5 \times 10^5$ cm/s and $A_{\text{eff}} \approx 350$ cm^2

- Power balance yields $n_e \approx 5.6 \times 10^{11}$ cm^{-3} and $n_{se} \approx 1.0 \times 10^{11}$ cm^{-3}

- Use n_{se} to find skin depth $\delta_p \approx 1.7$ cm; estimate $\nu_m = K_{\text{el}} n_g$ (K_{el} versus T$_e$ figure) to find $\nu_m \approx 1.4 \times 10^7$ s^{-1}

- Use ν_m and n_{se} to find $\sigma_{\text{dc}} \approx 113$ Ω^{-1}-m^{-1}

- Evaluate impedance elements $R_s \approx 14.7$ Ω and $L_s \approx 2.2$ μH; $|Z_s| \approx \omega L_s \approx 190$ Ω

- Power balance yields $\tilde{I}_{\text{rf}} \approx 9.0$A; from impedance $\tilde{V}_{\text{rf}} \approx 1720$ V

PLANAR COIL DISCHARGE

• Magnetic field produced by planar coil
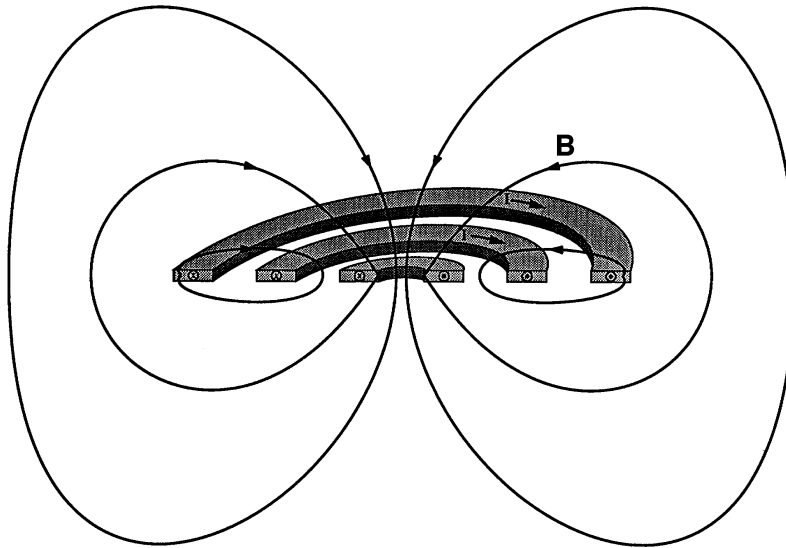

• RF power is deposited in ring-shaped plasma volume
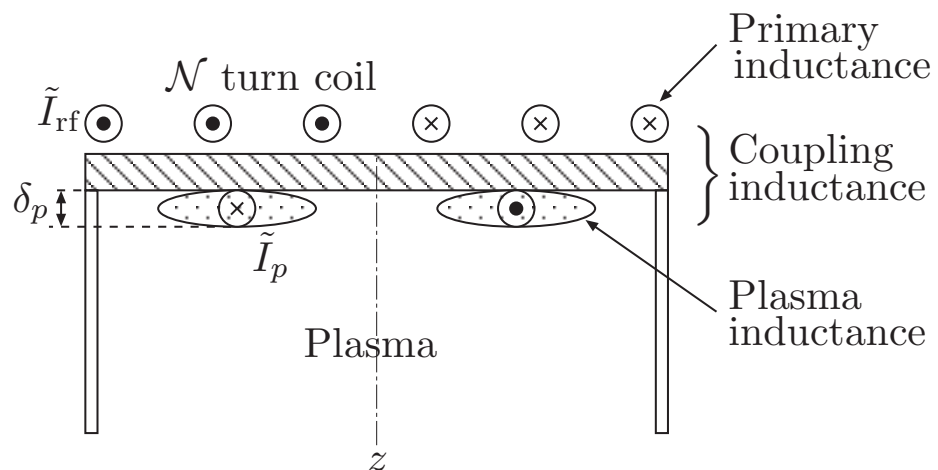
• As for a cylindrical discharge, there is a primary (L_{11}), coupling $(L_{12} = L_{21})$ and secondary $(L_p = L_{22})$ inductance

PLANAR COIL FIELDS

- A ring-shaped plasma forms because

$$\text{Induced electric field} = \begin{cases} 0, & \text{on axis} \\ \max, & \text{at } r \approx \frac{1}{2}R_{\text{wall}} \\ 0, & \text{at } r = R_{\text{wall}} \end{cases}$$

- Measured radial variation of B_r (and E_θ) at three distances below the window (5 mTorr argon, 500 W)
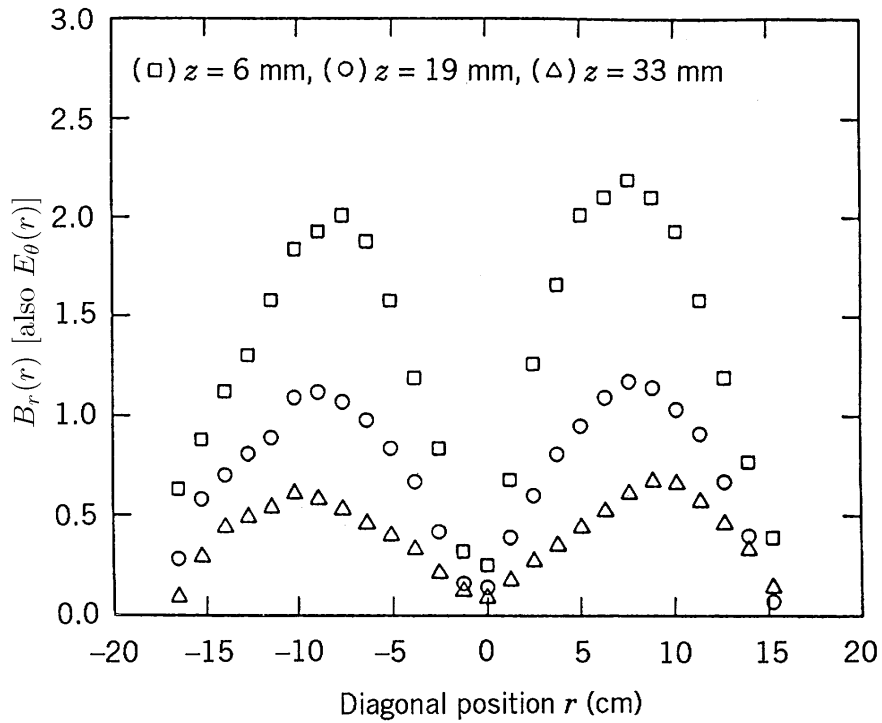
INDUCTIVE DISCHARGES

POWER BALANCE

RESISTANCE AT HIGH AND LOW DENSITIES

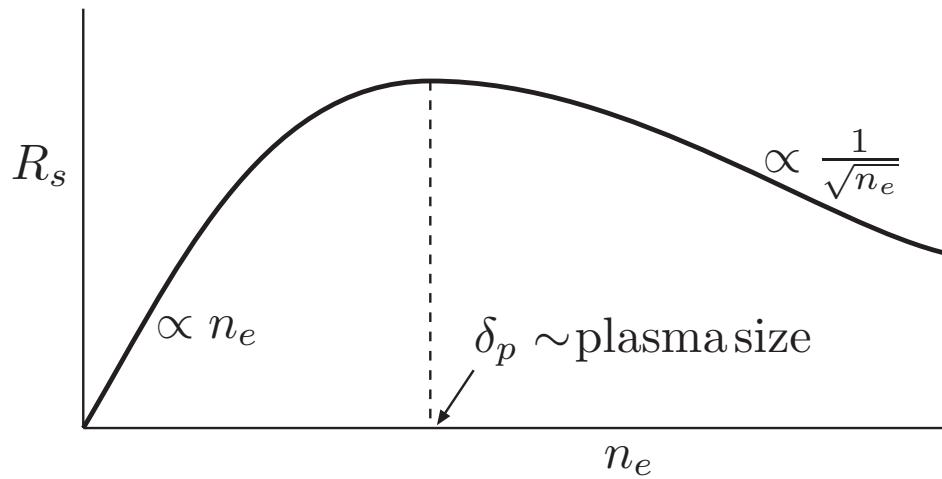- Plasma resistance seen by the coil

$$R_s = R_p \frac{\omega^2 L_{12}^2}{R_p^2 + \omega^2 L_p^2}$$

- High density (normal inductive operation)

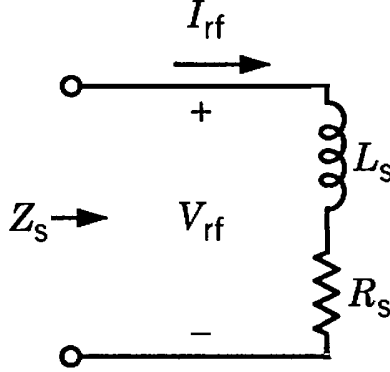$$R_s \approx R_p \propto \frac{1}{\sigma_{\mathrm{dc}} \delta_p} \propto \frac{1}{\sqrt{n_e}}$$

- Low density (skin depth > plasma size)

$$R_s \propto \text{ number of electrons in the heating volume} \propto n_e$$

POWER BALANCE WITHOUT MATCHING

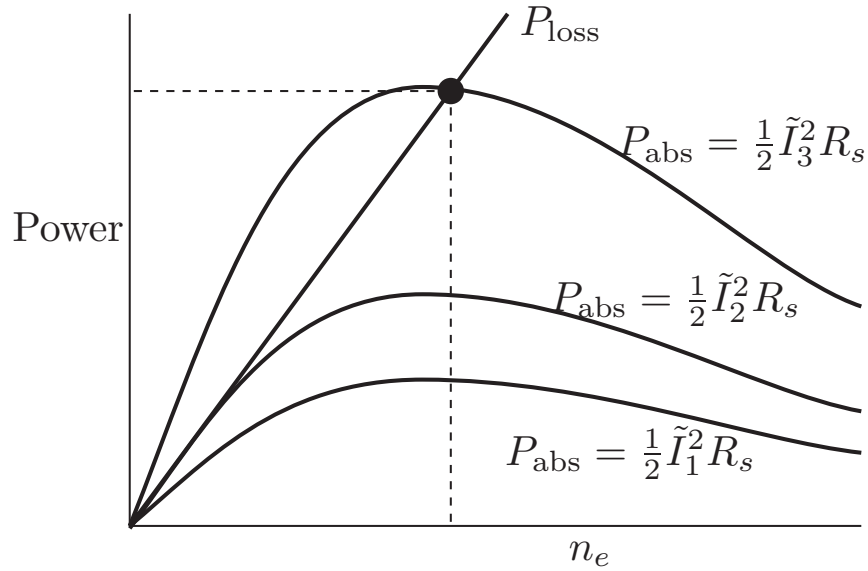- Drive discharge with rf current

- Power absorbed by discharge is $P_{\text{abs}} = \frac{1}{2}|\tilde{I}_{\text{rf}}|^2 R_s(n_e)$
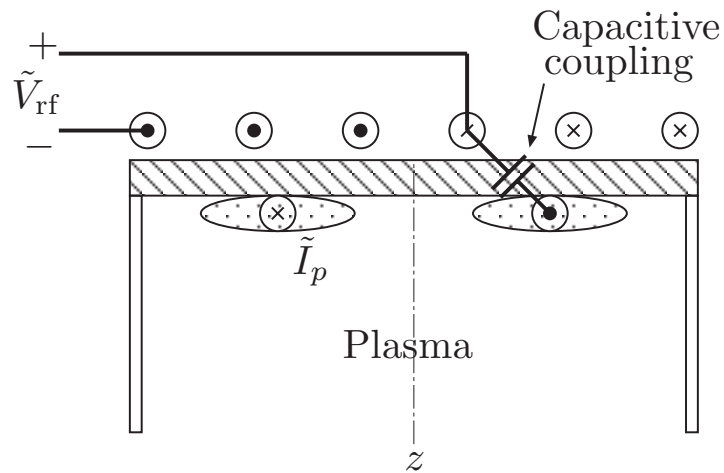
  Power lost by discharge $P_{\text{loss}} \propto n_e$

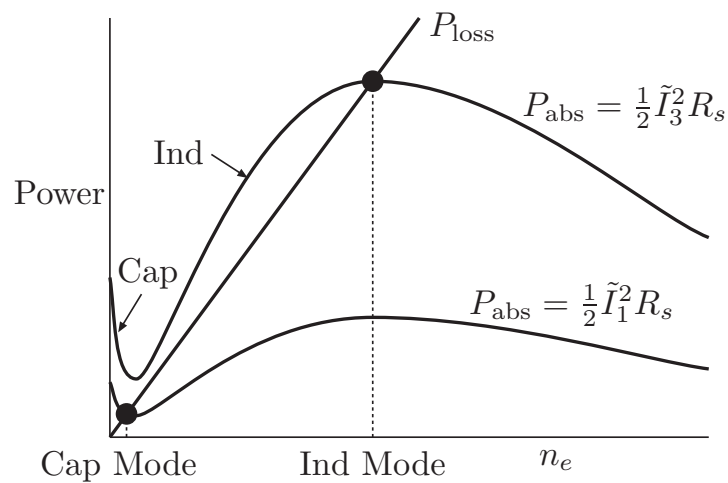- Intersection gives operating point; let $\tilde{I}_1 < \tilde{I}_2 < \tilde{I}_3$

- Inductive operation impossible for $\tilde{I}_{\text{rf}} \leq \tilde{I}_2$
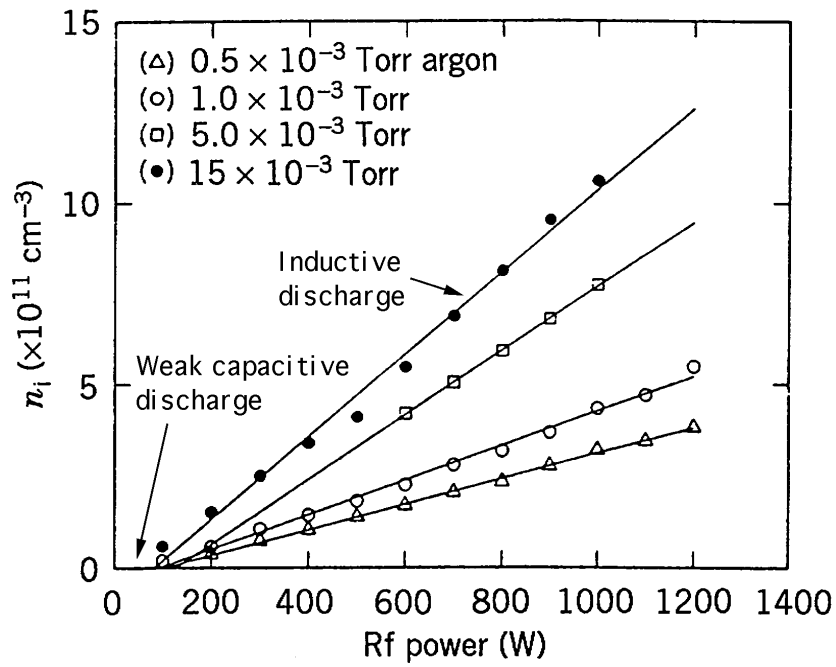
CAPACITIVE COUPLING OF COIL TO PLASMA

- For $\tilde{I}_{\mathrm{rf}}$ below the minimum current $\tilde{I}_2$, there is only a weak capacitive coupling of the coil to the plasma

- A small capacitive power is absorbed

    $\Longrightarrow$ low density capacitive discharge

MEASURMENTS OF ARGON ION DENSITY

- Above 100 W, discharge is inductive and $n_e \propto P_{\mathrm{abs}}$
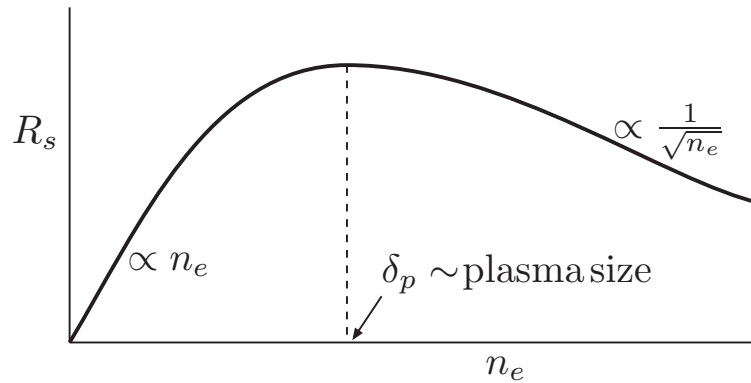
- Below 100 W, a weak capacitive discharge is present

SOURCE EFFICIENCY

- The source coil has some winding resistance R_{coil}

- R_{coil} is in series with the plasma resistance R_s

- Power transfer efficiency is

$$\eta = \frac{R_s}{R_s + R_{\text{coil}}}$$

- High efficiency $\implies$ maximum R_s

- Power transfer efficiency decreases at low and high densities

- Poor power transfer at low or high densities is analogous to poor power transfer in an ordinary transformer with an open or shorted secondary winding

CONCLUSIONS

- Plasma discharges are widely used for materials processing and are indispensible for microelectronics fabrication

- The coupling of the equations for the fields and the charged particles is the key to plasma analysis

- Neutral particles play a key role in ionization, energy loss, and diffusion processes in discharges

- The particle and energy balance relations are the key to the analysis of discharge equilibrium

- The particle balance determines the electron temperature; the energy balance determines the plasma density

- A transformer model along with the particle and energy balance relations are the key to the analysis of inductive discharges